Preliminary

MPU-3000/MPU-3050
Motion Processing Unit
Product Specification
Rev 2.9

CONTENTS

1 DOCUMENT INFORMATION 4

1.1 Revision History 4
1.2 Purpose and Scope 6
1.3 Product Overview 6
1.4 Software Solutions 7
1.5 Applications 9

2 FEATURES 10

2.1 Sensors 10
2.2 Digital Output 10
2.3 MotionProcessing 10
2.4 Clocking 10
2.5 Power 10
2.6 Package 11

3 ELECTRICAL CHARACTERISTICS 12

3.1 Sensor Specifications 12
3.2 Electrical Specifications 13
3.3 Electrical Specifications, continued 14
3.4 Electrical Specifications, continued 15
3.5 I^2C Timing Characterization 16
3.6 SPI Timing Characterization (MPU-3000 only) 17
3.7 Absolute Maximum Ratings 18

4 APPLICATIONS INFORMATION 19

4.1 Pin Out and Signal Description 19
4.2 Typical Operating Circuits 20
4.3 Bill of Materials for External Components 20
4.4 Recommended Power-on Procedure 21

5 FUNCTIONAL OVERVIEW 22

5.1 Block Diagram 22
5.2 Overview 22
5.3 Three-Axis MEMS Gyroscope with 16-bit ADCs and Signal Conditioning 22
5.4 Digital Motion Processor 23
5.5 Primary I^2C and SPI Serial Communications Interfaces 23
5.6 Secondary I^2C Serial Interface (for a third-party Accelerometer or other sensors) 24
5.7 Internal Clock Generation 26
5.8 Clock Output 27
5.9 Sensor Data Registers 27
5.10 FIFO 27
5.11 Interrupts 27
5.12 Digital-Output Temperature Sensor 27
5.13 Bias and LDO 27
5.14 Charge Pump 27
5.15 Chip Version 27

6 DIGITAL INTERFACE 28

6.1 I^2C and SPI (MPU-3000 only) Serial Interfaces 28

7 SERIAL INTERFACE CONSIDERATIONS (MPU-3050) 33

7.1 MPU-3050 Supported Interfaces 33

Preliminary

7.2 LOGIC LEVELS 33
8 ASSEMBLY 36
8.1 ORIENTATION OF AXES 36
8.2 PACKAGE DIMENSIONS: 37
8.3 PCB DESIGN GUIDELINES: 38
8.4 ASSEMBLY PRECAUTIONS 39
8.5 PACKAGE MARKING SPECIFICATION 42
8.6 TAPE & REEL SPECIFICATION 43
8.7 LABEL 44
8.8 PACKAGING 45
9 RELIABILITY 46
9.1 QUALIFICATION TEST POLICY 46
9.2 QUALIFICATION TEST PLAN 46
10 ENVIRONMENTAL COMPLIANCE 47

Preliminary

1 Document Information

1.1 Revision History

Revision Date	Revision	Description
06/25/09	1.0	Initial Release
09/28/09	2.0	Changes for revision level compliance of MPU-30X0 to MPU-3000 Specification: Sec. 1.2 Added Revision B1 silicon note Sec. 1.3 Updated noise specification to 0.03º/s/√Hz Sec. 2.3 Added secondary I^2C interface Sec. 3.1 Updated sensor specifications table Sec. 3.2 Changed VDD to 2.5V and $T_A = 25^0C$ Sec. 3.2-3.3 Changed electrical specifications table format and typical values Sec. 4.1 Updated pin-out and signal descriptions with new diagram Sec. 4.2 Updated typical operating circuit diagram Sec. 5.1 Updated new block diagram descriptions for primary and secondary I^2C serial interfaces Sec. 5.9 Changed FIFO description Sec. 6 Edited digital interface Sec. 10.2 Updated package drawing/dimensions Sec. 10.7 Edited trace routing Sec. 13 Added Appendix 1.0, Errata for Revision G devices
11/5/09	2.1	Sec. 10 Added Material Handling Specification content
12/23/09	2.2	Sec. 3.2 Updated Electrical Specifications with Power-Supply Ramp Rate for VLOGIC Reference Voltage Sec. 3.3 Updated Level Output Current specifications for the Primary and Secondary I^2C interfaces Sec. 3.4 Updated Frequency Variation Over Temperature Specification for Internal Clock Source Sec. 3.5.1 Updated ESD Specification Sec. 4.4 Added recommended Power-On Procedure diagram
03/15/2010	2.3	Sec. 1.4 Added new InvenSense trademarks under Applications Sec. 2.2 Edited Digital Output for 400KHz standard (not up to) Sec. 3.1 Changed Sensitivity Scale Factor to 115 LSB/(º/s) Sec. 4.4 Updated Recommended Power-on Procedure diagram Sec. 8.2 Modified Example Power Configuration diagram to remove IME-3000 reference Sec. 11.2 Updated ESD-HBM for Device Component Level Tests. Removed all references to IME-3000 and replaced with third-party accelerometer.
08/17/2010	2.4	Sec. 3.1 Updated sensitivity scale factor, ZRO, Noise performance Sec. 3.2 Added operating current for case without DMP Added start-up time Sec. 8.2 Updated table with reference to AUX_VDDIO Sec. 9.1 Added Demo Software Section Sec. 10-11 Added Register Maps and Register Description Sections Sec. 12.9 Updated table and accompanying text Sec. 12.11 Added Storage Specifications Section Sec. 14 Added Environment Compliance Section
08/26/2010	2.4b	Sec. 3.2-3.3 Updated specifications for C_i Sec. 3.5 Updated specifications for C_b Sec. 3.3 Updated V_{IH} and V_{hys}

Preliminary

Revision Date	Revision	Description	
12/23/2010	2.5	Sec. 9	Removed MPL section. Created a separate document for Register Information
03/03/2011	2.6	Sec. 2.2 Sec. 4.3 Sec. 5.5 Sec. 5.5 Sec. 5.6 Sec. 5.6 Sec. 7.2 Sec. 8	Clarified SPI Usage case Fixed C1 and C2 Specifications Clarified SPI Usage case Documented inoperable primary bus when VDD is low and interface pins are low impedance Documented gyro access capability in Pass-Through Mode Documented the Secondary I^2C bus Internal Pull Up configuration Modified diagrams to clarify usage of 3rd party accelerometers Modified assembly rules and Moisture Sensitivity Level (MSL) Labels
05/19/2011	2.7	Sec. 1.2 Sec. 1.4 Sec. 3.2 Sec. 3.2 Sec. 4.4 Sec. 5.6 Sec. 8.4.3 Sec. 8.5 Sec. 8.8	Updated Software References Added section describing InvenSense software solutions Clarified Digital Input and Digital Output specifications Added CLKOUT Digital Out Specifications Clarified $T_{VLG-VDD}$ value Modified diagrams for clarity Clarified Trace Routing precautions Modified Package Marking diagrams for clarity Updated packaging images
06/13/2011	2.8	Sec. 3.5 Sec. 4.1 Sec. 4.4	Specified I^2C Timing Specifications as only for the Primary I^2C bus. Added reference to App Note for details regarding the Auxiliary I^2C bus specifications. Specified CLKIN and FSYNC to be connected to GND if unused. Modified T_{VDDR} value for consistency with Electrical Characteristics. Modified Power Up Sequencing Notes for clarity
11/14/2011	2.9	Sec. 3.7 Sec. 8.5	Updated absolute maximum rating for acceleration Updated package marking description

Preliminary

1.2 Purpose and Scope

This document is a product specification, providing a description, specifications, and design related information for the MPU-3000™ and MPU-3050™ Motion Processing Unit™ (collectively called the MPU-30X0™).

Electrical characteristics are based upon simulation results and limited characterization data of advanced samples only. Specifications are subject to change without notice. Final specifications will be updated based upon characterization of final silicon.

1.3 Product Overview

The MPU-30X0 Motion Processing Unit (MPU™) is the world's first MotionProcessing™ solution with integrated 6-axis sensor fusion using its field-proven and proprietary MotionFusion™ engine for smart phone applications. The MPU-30X0 has an embedded 3-axis gyroscope and Digital Motion Processor™ (DMP) hardware accelerator engine with a secondary I^2C port that interfaces to third party digital accelerometers to deliver a complete 6-axis sensor fusion output to its primary I^2C port. This combines both linear and rotational motion into a single data stream for the application. This breakthrough in gyroscope technology provides a dramatic 68% smaller footprint, 40% thinner package, consumes 55% less power, and has inherent cost advantages compared to the latest competitive gyro solutions to uniquely address the fast-growing demand for 6-axis MotionProcessing in mobile handsets. The primary interface also supports SPI protocol on the MPU-3000 and can be used to read/write to all the registers on the part. The MPU's memory and FIFO are not accessible via the SPI interface.

The MPU-30X0 significantly extends and transforms motion sensing features provided by accelerometers beyond portrait and landscape orientation, to MotionProcessing functionality. The MPU measures and processes both linear and rotational movements, creating a higher degree of 1:1 motion interactivity between the user and their handset. Similar to the proliferation of Bluetooth, camera phone image sensors and Wi-Fi, MotionProcessing is becoming a "must-have" function in mobile handsets benefitting wireless carriers, mobile handset OEMs, application developers and end-users. By providing an integrated sensor fusion output, the DMP in the MPU-30X0 offloads the intensive MotionProcessing computation requirements from the applications processor, reducing the need for frequent polling of the motion sensor output and enabling use of low cost, low power application processors thereby increasing overall battery life of handsets. Since handsets today are of multi-function nature, MPU-30X0 not only provides accurate 1:1 motion tracking for some of the more common applications such as still/video image stabilization, gaming and dead reckoning, the 32-bit DMP can be programmed to deliver advanced UI, e.g. multiple kinds of gestures and character recognition leading to applications such as *Airsign*™, *TouchAnywhere*™, *MotionCommand*™.

By leveraging its patented and volume-proven Nasiri-Fabrication platform, which integrates MEMS wafers with companion CMOS electronics through wafer-level bonding, InvenSense has driven the MPU-30X0 package size down to a revolutionary footprint of 4x4x0.9mm (QFN), while providing the highest performance, lowest noise, and the lowest cost semiconductor packaging to address a wide range of handheld consumer electronic devices.

Preliminary

The MPU-30X0 integrates 16-bit analog-to-digital converters (ADCs), selectable low-pass filters, FIFO, embedded temperature sensor, and Fast Mode I^2C or SPI (MPU-3000 only) interfaces. Performance features include programmable full-scale range from ±250 degrees-per-second up to ±2000 degrees-per-second (º/s or dps), and low-noise of 0.01º/s/√Hz, while providing the highest robustness supporting 10,000*g* shock in operation. The highest cross-axis isolation is achieved by design from its single silicon integration. Factory-calibrated initial sensitivity reduces production-line calibration requirements. The part's on-chip FIFO and dedicated I^2C-master accelerometer sensor bus simplify system timing and lower system power consumption. The sensor bus allows the MPU-30X0 to directly acquire data from the off-chip accelerometer without intervention from an external processor. Other industry-leading features include a small 4mmx4mmx0.9mm plastic QFN package, an embedded temperature sensor, programmable interrupts, and a low 13mW power consumption. Parts are available with I^2C and SPI serial interfaces, a VDD operating range of 2.1 to 3.6V, and a VLOGIC interface voltage from 1.71V to 3.6V.

The MPU-3000 and MPU-3050 are identical, except that the MPU-3050 supports the I^2C serial interface only, and has a separate VLOGIC reference pin (in addition to its analog supply pin, VDD), which sets the logic levels of its I^2C interface. The VLOGIC voltage may be between 1.71V min to VDD max. The MPU-3000 supports both I^2C and SPI interfaces and has a single supply pin, VDD, which is the device's logic reference supply and the analog supply for the part. The table below outlines these differences:

Primary Differences between MPU-3000 and MPU-3050

Part / Item	MPU-3000	MPU-3050
VDD	2.1V to 3.6V	2.1V to 3.6V
VLOGIC	n/a	1.71V to VDD
Serial Interfaces Supported	I^2C, SPI	I^2C
Pin 8	/CS	VLOGIC
Pin 9	AD0/SDO	AD0
Pin 23	SCL/SCLK	SCL
Pin 24	SDA/SDI	SDA

1.4 Software Solutions

This section describes the MotionApps™ software solutions included with the InvenSense MPU™ (MotionProcessing Unit™) and IMU (Inertial Measurement Unit) product families. Please note that the products within the IDG, IXZ, and ITG families do not include these software solutions.

The MotionApps Platform is a complete software solution that in combination with the InvenSense IMU and MPU MotionProcessor™ families delivers robust, well-calibrated 6-axis and/or 9-axis sensor fusion data using its field proven and proprietary MotionFusion™ engine. Solution packages are available for smartphones and tablets as well as for embedded microcontroller-based devices.

The MotionApps Platform provides a turn-key solution for developers and accelerates time-to-market. It consists of complex 6/9-axis sensor fusion algorithms, robust multi-sensor calibration, a proven software architecture for Android and other leading operating systems, and a flexible power management scheme.

The MotionApps Platform is integrated within the middleware of the target OS (the sensor framework), and also provides a kernel device driver to interface with the physical device. This directly benefits application developers by providing a cohesive set of APIs and a well-defined sensor data path in the user-space.

Preliminary

The table below describes the MotionApps software solutions included with the InvenSense MPU and IMU product families.

InvenSense MotionProcessor Devices and Included MotionApps Software

Feature	Included Software				Notes
	MotionApps	Embedded MotionApps	MotionApps Lite	Embedded MotionApps Lite	
Part Number	MPU-3050™ MPU-6050™		IMU-3000™		
Processor Type	Mobile Application Processor	8/16/32-bit Microcontroller	Mobile Application Processor	8/16/32-bit Microcontroller	
Applications	Smartphones, tablets	TV remotes, health/fitness, toys, other embedded	Smartphones, tablets	TV remotes, health/fitness, toys, other embedded	
6-Axis MotionFusion	Yes		Yes		< 2% Application Processor load using on-chip Digital Motion Processor (DMP).
9-Axis MotionFusion	Yes		No		Reduces processing requirements for embedded applications
Gyro Bias Calibration	Yes		Yes		No-Motion calibration and temperature calibration
3rd Party Compass Cal API	Yes		No		Integrates 3rd party compass libraries
Gyro-Assisted Compass Calibration (Fast Heading)	Yes		No		Quick compass calibration using gyroscope
Magnetic Anomaly Rejection (Improved Heading)	Yes		No		Uses gyro heading data when magnetic anomaly is detected

The table below lists recommended documentation for the MotionApps software solutions.

Software Documentation

Platform	MotionApps and MotionApps Lite	Embedded MotionApps and Embedded MotionApps Lite
Software Documentation	• Installation Guide for Linux and Android MotionApps Platform, v1.9 or later • MPL Functional Specifications	• Embedded MotionApps Platform User Guide, v3.0 or later • Embedded MPL Functional Specifications

For more information about the InvenSense MotionApps Platform, please visit the Developer's Corner or consult your local InvenSense Sales Representative.

Preliminary

1.5 Applications

- *BlurFree*™ technology (for Video/Still Image Stabilization)
- *AirSign*™ technology (for Security/Authentication)
- *TouchAnywhere*™ technology (for Application Control/Navigation)
- *MotionCommand*™ technology (for Gesture Short-cuts)
- Motion-enabled game and application framework
- InstantGesture™ iG™ gesture recognition
- “No Touch” UI
- Handset gaming
- Location based services, points of interest, and dead reckoning
- Improved camera image quality through image stabilization
- Health and sports monitoring
- Power management

Preliminary

2 Features

The MPU-30X0 Motion Processing Unit includes a wide range of features:

2.1 Sensors

- X-, Y-, Z-Axis angular rate sensors (gyros) on one integrated circuit
- Digital-output temperature sensor
- External sync signal connected to the FSYNC pin supports image, video and GPS synchronization
- 6-axis MotionProcessing capability using secondary I^2C interface to directly connect to a digital 3-axis third-party accelerometer
- Factory calibrated scale factor
- High cross-axis isolation via proprietary MEMS design
- 10,000*g* shock tolerant

2.2 Digital Output

- Fast Mode (400kHz) I^2C
- 1MHz SPI (MPU-3000 only) to access gyro, temp and auxiliary sensor registers only; aimed at higher speed applications which need raw data, refer to Section 5.5 for further explanation
- 16-bit ADCs for digitizing sensor outputs
- Angular rate sensors (gyros) with applications-programmable full-scale-range of ±250°/sec, ±500°/sec, ±1000°/sec, or ±2000°/sec.

2.3 MotionProcessing

- Embedded Digital Motion Processing™ (DMP™) engine supports 3D MotionProcessing and gesture recognition algorithms
- When used together with a digital 3-axis third party accelerometer, the MPU-30X0 collects the accelerometer data via a dedicated interface, while synchronizing data sampling at a user defined rate. The total data set obtained by the MPU-30X0 includes 3-axis gyroscope data and 3-axis accelerometer data, temperature data, and the one bit external sync signal connected to the FSYNC pin. The MPU also downloads the results calculated by the digital 3-axis third party accelerometer internal registers.
- FIFO buffers complete data set, reducing timing requirements on the system processor and saving power by letting the processor burst read the FIFO data, and then go into a low-power sleep mode while the MPU collects more data.
- Programmable interrupt supports features such as gesture recognition, panning, zooming, scrolling, zero-motion detection, tap detection, and shake detection
- Hand jitter filter
- Programmable low-pass filters
- Feature extraction for peak and zero-crossing detection
- Pedometer functionality

2.4 Clocking

- On-chip timing generator clock frequency ±1% over full temperature range
- Optional external clock inputs of 32.768kHz or 19.2MHz
- 1MHz clock output to synchronize with digital 3-axis accelerometer

2.5 Power

- VDD supply voltage range of 2.1V to 3.6V
- Flexible VLOGIC reference voltage allows for multiple I^2C interface voltage levels (MPU-3050 only)
- Power consumption with all three axes and DMP active: 6.1mA
- Sleep mode: 5µA
- Each axis can be individually powered down

Preliminary

2.6 Package

- 4x4x0.9mm QFN plastic package
- MEMS structure hermetically sealed and bonded at wafer level
- RoHS and Green compliant

Preliminary

3 Electrical Characteristics

3.1 Sensor Specifications

Typical Operating Circuit of Section 4.2, VDD = 2.5V, VLOGIC = 2.5V (MPU-3050 Only), T_A=25°C.

Parameter	Conditions	Min	Typical	Max	Unit	Notes
GYRO SENSITIVITY						
Full-Scale Range	FS_SEL=0		±250		º/s	4, 7
	FS_SEL=1		±500			4, 7
	FS_SEL=2		±1000			4, 7
	FS_SEL=3		±2000			4, 7
Gyro ADC Word Length			16		bits	3
Sensitivity Scale Factor	FS_SEL=0		131		LSB/(º/s)	1
	FS_SEL=1		65.5			3
	FS_SEL=2		32.8			3
	FS_SEL=3		16.4			3
Sensitivity Scale Factor Tolerance	25°C	-6	±2	+6	%	1
Sensitivity Scale Factor Variation Over Temperature	-40°C to +85°C		±2		%	8
Nonlinearity	Best fit straight line; 25°C		0.2		%	6
Cross-Axis Sensitivity			2		%	6
GYRO ZERO-RATE OUTPUT (ZRO)						
Initial ZRO Tolerance	25°C		±20		º/s	1
ZRO Variation Over Temperature	-40°C to +85°C		±0.03		º/s/°C	8
Power-Supply Sensitivity (1-10Hz)	Sine wave, 100mVpp; VDD=2.2V		0.2		º/s	5
Power-Supply Sensitivity (10 - 250Hz)	Sine wave, 100mVpp; VDD=2.2V		0.2		º/s	5
Power-Supply Sensitivity (250Hz - 100kHz)	Sine wave, 100mVpp; VDD=2.2V		4		º/s	5
Linear Acceleration Sensitivity	Static		0.1		º/s/*g*	6
GYRO NOISE PERFORMANCE	**FS_SEL=0**					
Total RMS Noise	DLPFCFG=2 (100Hz)		0.1		º/s-rms	1
Low-frequency RMS noise	Bandwidth 1Hz to10Hz		0.033		º/s-rms	1
Rate Noise Spectral Density	At 10Hz		0.01		º/s/√Hz	3
GYRO MECHANICAL FREQUENCIES						
X-Axis		30	33	36	kHz	1
Y-Axis		27	30	33	kHz	1
Z-Axis		24	27	30	kHz	1
GYRO START-UP TIME	**DLPFCFG=0**					
ZRO Settling	to ±1º/s of Final		50		ms	5
TEMPERATURE SENSOR						
Range			-30 to 85		ºC	2
Sensitivity	Untrimmed		280		LSB/ºC	2
Room-Temperature Offset	35°C		-13200		LSB	1
Linearity	Best fit straight line (-30°C to +85°C)		±1		°C	2
TEMPERATURE RANGE						
Specified Temperature Range		-40		85	ºC	2

Notes:

1. Tested in production
2. Based on characterization of 30 parts over temperature on evaluation board or in socket
3. Based on design, through modeling, and simulation across PVT
4. Typical. Randomly selected part measured at room temperature on evaluation board or in socket
5. Based on characterization of 5 parts over temperature
6. Tested on 20 parts at room temperature
7. Part is characterized to Full-Scale Range. Maximum ADC output is [2^{16} / (Sensitivity x 2)]
   Example: For Sensitivity of 131 LSB/(º/s), [2^{16} / (131 x 2)] = ±250 º/s.
8. Based on characterization of 48 parts on evaluation board or in socket

Preliminary

3.2 Electrical Specifications

Typical Operating Circuit of Section 4.2, VDD = 2.5V, VLOGIC = 2.5V (MPU-3050 only), T_A = 25°C.

Parameters	Conditions	Min	Typical	Max	Units	Notes
VDD POWER SUPPLY						
Operating Voltage Range		2.1		3.6	V	2
Power-Supply Ramp Rate	Monotonic ramp. Ramp rate is 10% to 90% of the final value (see Figure in Section 4.4)	0		5	ms	2
Normal Operating Current			6.1		mA	1
	DMP disabled		5.9		mA	1
Sleep Mode Current			5		µA	4
VLOGIC REFERENCE VOLTAGE (must be regulated)						
Voltage Range	VLOGIC must be ≤VDD at all times	1.71		VDD	V	3, 5
Power-Supply Ramp Rate	Monotonic ramp. Ramp rate is 10% to 90% of the final value (see Figure in Section 4.4)			1	ms	3, 5
Normal Operating Current	Does not include pull up resistor current draw as that is system dependent		100		µA	4
START-UP TIME FOR REGISTER READ/WRITE			20	100	ms	4
I^2C ADDRESS	AD0 = 0		1101000			1
	AD0 = 1		1101001			1
DIGITAL INPUTS (SDI/SDA, SCLK/SCL, FSYNC, AD0, /CS, CLKIN)						
V_{IH}, High Level Input Voltage	MPU-3000	0.7*VDD			V	4
	MPU-3050	0.7*VLOGIC			V	4
V_{IL}, Low Level Input Voltage	MPU-3000			0.3*VDD	V	4
	MPU-3050			0.3*VLOGIC	V	4
C_I, Input Capacitance			< 5		pF	6
DIGITAL OUTPUT (SDO, INT)						
V_{OH}, High Level Output Voltage	R_{LOAD}=1MΩ; MPU-3000	0.9*VDD			V	2
	R_{LOAD}=1MΩ; MPU-3050	0.9*VLOGIC			V	2
V_{OL1}, LOW-Level Output Voltage	R_{LOAD}=1MΩ; MPU-3000			0.1*VDD	V	2
	R_{LOAD}=1MΩ; MPU-3050			0.1*VLOGIC	V	2
$V_{OL.INT1}$, INT Low-Level Output Voltage	OPEN=1, 0.3mA sink current			0.1	V	2
Output Leakage Current	OPEN=1		100 50		nA	3
t_{INT}, INT Pulse Width	LATCH_INT_EN=0				µs	3
DIGITAL OUTPUT (CLKOUT)						
V_{OH}, High Level Output Voltage	RLOAD=1MΩ	0.9*VDD			V	2
V_{OL1}, LOW-Level Output Voltage	RLOAD=1MΩ			0.1*VDD	V	2

Notes:

1. Tested in production
2. Based on characterization of 30 parts over temperature on evaluation board or in socket
3. Typical. Randomly selected part measured at room temperature on evaluation board or in socket
4. Based on characterization of 5 parts over temperature
5. Refer to Section 4.4 for the recommended power-on procedure
6. Guaranteed by design

Preliminary

3.3 Electrical Specifications, continued

Typical Operating Circuit of Section 4.2, VDD = 2.5V, VLOGIC = 2.5V (MPU-3050 only), T_A=25°C.

Parameters	Conditions	Typical	Units	Notes
Primary I^2C I/O (SCL, SDA)				
V_{IL}, LOW-Level Input Voltage	MPU-3000	-0.5 to 0.3*VDD	V	1
V_{IH}, HIGH-Level Input Voltage	MPU-3000	0.7*VDD to VDD + 0.5V	V	1
V_{hys}, Hysteresis	MPU-3000	0.1*VDD	V	1
V_{IL}, LOW Level Input Voltage	MPU-3050	-0.5V to 0.3*VLOGIC	V	1
V_{IH}, HIGH-Level Input Voltage	MPU-3050	0.7*VLOGIC to VLOGIC + 0.5V	V	1
V_{hys}, Hysteresis	MPU-3050	0.1*VLOGIC	V	1
V_{OL1}, LOW-Level Output Voltage	3mA sink current	0 to 0.4	V	1
I_{OL}, LOW-Level Output Current	V_{OL} = 0.4V V_{OL} = 0.6V	3 5	mA mA	1 1
Output Leakage Current		100	nA	2
t_{of}, Output Fall Time from V_{IHmax} to V_{ILmax}	C_b bus capacitance in pf	20+0.1C_b to 250	ns	1
C_I, Capacitance for Each I/O pin		< 10	pF	3
Secondary I^2C I/O (AUX_CL, AUX_DA)	**AUX_VDDIO=0 (MPU-3050)**			
V_{IL}, LOW-Level Input Voltage		-0.5V to 0.3*VLOGIC	V	1
V_{IH}, HIGH-Level Input Voltage		0.7*VLOGIC to VLOGIC + 0.5V	V	1
V_{hys}, Hysteresis		0.1*VLOGIC	V	1
V_{OL1}, LOW-Level Output Voltage	VLOGIC > 2V; 1mA sink current	0 to 0.4	V	1
V_{OL3}, LOW-Level Output Voltage	VLOGIC < 2V; 1mA sink current	0 to 0.2*VLOGIC	V	1
I_{OL}, LOW-Level Output Current	V_{OL} = 0.4V V_{OL} = 0.6V	1 1	mA mA	1 1
Output Leakage Current		100	nA	2
t_{of}, Output Fall Time from V_{IHmax} to V_{ILmax}	C_b bus capacitance in pF	20+0.1C_b to 250	ns	1
C_I, Capacitance for Each I/O pin		< 10	pF	3
Secondary I^2C I/O (AUX_CL, AUX_DA)	**AUX_VDDIO=1**			
V_{IL}, LOW-Level Input Voltage		-0.5 to 0.3*VDD	V	1
V_{IH}, HIGH-Level Input Voltage		0.7*VDD to VDD+0.5V	V	1
V_{hys}, Hysteresis		0.1*VDD	V	1
V_{OL1}, LOW-Level Output Voltage	1mA sink current	0 to 0.4	V	1
I_{OL}, LOW-Level Output Current	V_{OL} = 0.4V V_{OL} = 0.6V	1 1	mA mA	1 1
Output Leakage Current		100	nA	2
t_{of}, Output Fall Time from V_{IHmax} to V_{ILmax}	C_b bus cap. in pF	20+0.1C_b to 250	ns	1
C_I, Capacitance for Each I/O pin		< 10	pF	3

Notes:

1. Based on characterization of 5 parts over temperature.
2. Typical. Randomly selected part measured at room temperature on evaluation board or in socket
3. Guaranteed by design

Preliminary

3.4 Electrical Specifications, continued

Typical Operating Circuit of Section 4.2, VDD = 2.5V, VLOGIC = 2.5V (MPU-3050 only), T_A=25°C.

Parameters	Conditions	Min	Typical	Max	Units	Notes
INTERNAL CLOCK SOURCE	**CLK_SEL=0,1,2,3**					
Sample Rate, Fast	DLPFCFG=0 SAMPLERATEDIV = 0		8		kHz	3
Sample Rate, Slow	DLPFCFG=1,2,3,4,5, or 6 SAMPLERATEDIV = 0		1		kHz	3
Reference Clock Output	CLKOUTEN = 1		1.024		MHz	3
Clock Frequency Initial Tolerance	CLK_SEL=0, 25°C	-5		+5	%	1
	CLK_SEL=1,2,3; 25°C	-1		+1	%	1
Frequency Variation over Temperature	CLK_SEL=0		-15 to +10		%	2
	CLK_SEL=1,2,3		+/-1		%	2
PLL Settling Time	CLK_SEL=1,2,3		1		ms	4
EXTERNAL 32.768kHz CLOCK	**CLK_SEL=4**					
External Clock Frequency			32.768		kHz	4
External Clock Jitter	Cycle-to-cycle rms		1 to 2		µs	4
Sample Rate, Fast	DLPFCFG=0 SAMPLERATEDIV = 0		8.192		kHz	4
Sample Rate, Slow	DLPFCFG=1,2,3,4,5, or 6 SAMPLERATEDIV = 0		1.024		kHz	4
Reference Clock Output	CLKOUTEN = 1		1.0486		MHz	4
PLL Settling Time			1		ms	4
EXTERNAL 19.2MHz CLOCK	**CLK_SEL=5**					
External Clock Frequency			19.2		MHz	4
Sample Rate, Fast	DLPFCFG=0 SAMPLERATEDIV = 0		8		kHz	4
Sample Rate, Slow	DLPFCFG=1,2,3,4,5, or 6 SAMPLERATEDIV = 0		1		kHz	4
Reference Clock Output	CLKOUTEN = 1		1.024		MHz	4
PLL Settling Time			1		ms	4

Notes:

1. Tested in production
2. Based on characterization of 30 parts over temperature on evaluation board or in socket
3. Typical. Randomly selected part measured at room temperature on evaluation board or in socket
4. Based on design, through modeling, and simulation across PVT

Preliminary

3.5 I²C Timing Characterization

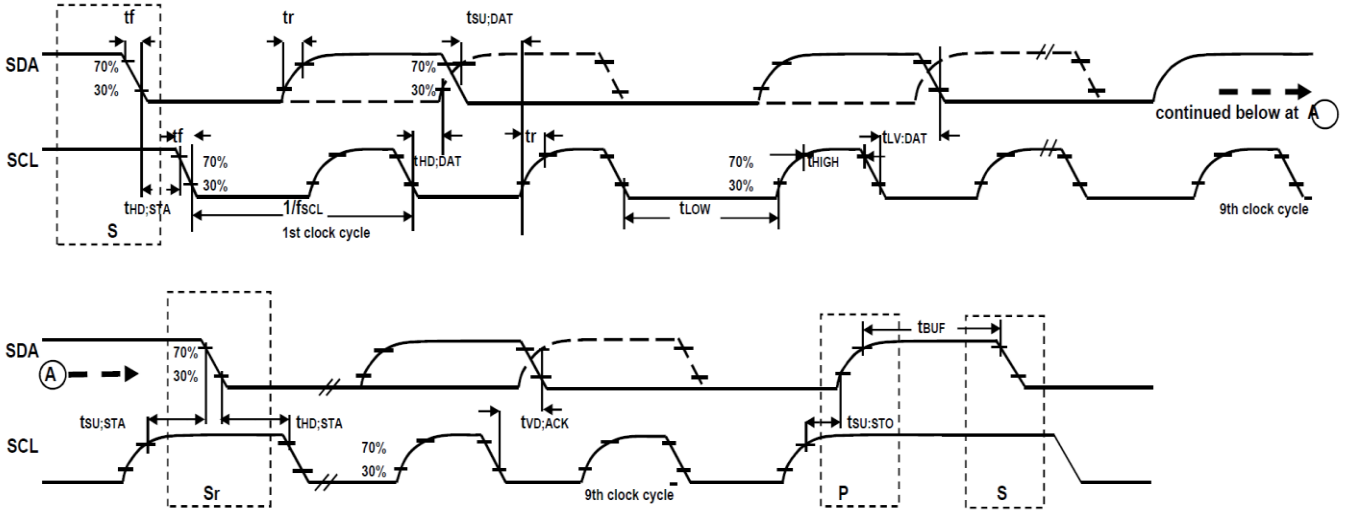
Typical Operating Circuit of Section 4.2, VDD = 2.5V, VLOGIC = 1.8V±5% (MPU-3050 only), 2.5V±5%, 3.0V±5%, or 3.3V±5%, T_A=25°C.

Parameters	Conditions	Min	Typical	Max	Units	Notes
I²C TIMING	**I²C FAST-MODE**					
f_{SCL}, SCL Clock Frequency		0		400	kHz	1
$t_{HD.STA}$, (Repeated) START Condition Hold Time		0.6			µs	1
t_{LOW}, SCL Low Period		1.3			µs	1
t_{HIGH}, SCL High Period		0.6			µs	1
$t_{SU.STA}$, Repeated START Condition Setup Time		0.6			µs	1
$t_{HD.DAT}$, SDA Data Hold Time		0			µs	1
$t_{SU.DAT}$, SDA Data Setup Time		100			ns	1
t_r, SDA and SCL Rise Time	C_b bus cap. from 10 to 400pF	20+0.1 C_b		300	ns	1
t_f, SDA and SCL Fall Time	C_b bus cap. from 10 to 400pF	20+0.1 C_b		300	ns	1
$t_{SU.STO}$, STOP Condition Setup Time		0.6			µs	1
t_{BUF}, Bus Free Time Between STOP and START Condition		1.3			µs	1
C_b, Capacitive Load for each Bus Line			< 400		pF	3
$t_{VD.DAT}$, Data Valid Time				0.9	µs	1
$t_{VD.ACK}$, Data Valid Acknowledge Time				0.9	µs	1

Notes:

1. Based on characterization of 5 parts over temperature on evaluation board or in socket
2. S = Start Condition, P = Stop Condition, S_r = Repeated Start Condition
3. Guaranteed by design

Note: Specifications apply to the Primary I²C bus only. For Auxiliary I²C bus specifications, please refer to the Application Note, AN-MPU-3000A-20.



I²C Bus Timing Diagram

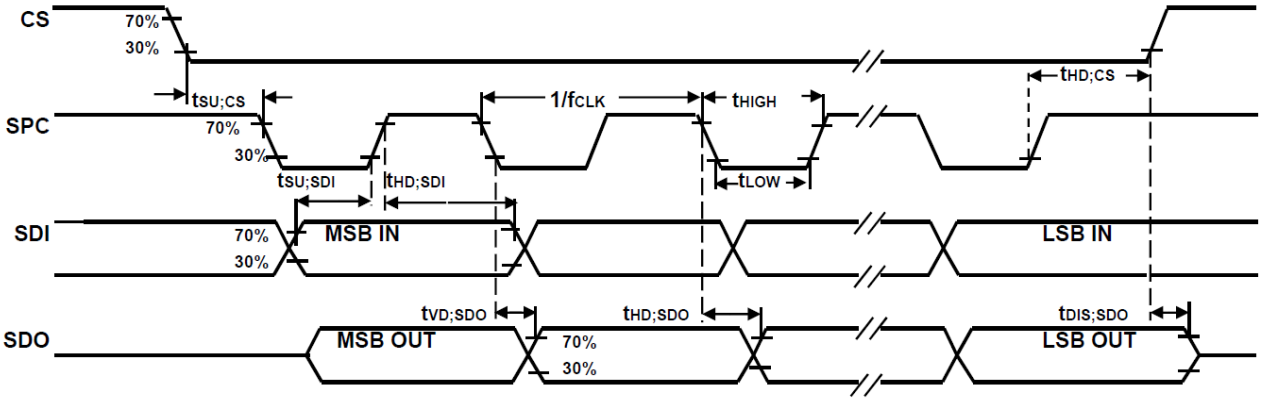
3.6 SPI Timing Characterization (MPU-3000 only)

Typical Operating Circuit of Section 4.2, VDD = 2.1V to 3.6V, T_A = -40°C to +85°C, unless otherwise noted. Typical values are at T_A=25°C.

Parameters	Conditions	Min	Typical	Max	Units
SPI TIMING					
f_{SCLK}, SCLK Clock Frequency		0.9		1	MHz
t_{LOW}, SCLK Low Period		400			ns
t_{HIGH}, SCLK High Period		400			ns
$t_{SU.CS}$, CS Setup Time		8			ns
$t_{HD.CS}$, CS Hold Time		500			ns
$t_{SU.SDI}$, SDI Setup Time		11			ns
$t_{HD.SDI}$, SDI Hold Time		7			ns
$t_{VD.SDO}$, SDO Valid Time	C_{load} = 20pF			100	ns
$t_{HD.SDO}$, SDO Hold Time	C_{load} = 20pF	4			ns
$t_{DIS.SDO}$, SDO Output Disable Time				10	ns

Note:

1. Based on characterization of 5 parts over temperature as mounted on evaluation board or in sockets



SPI Bus Timing Diagram

Preliminary

3.7 Absolute Maximum Ratings

Stress above those listed as “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these conditions is not implied. Exposure to the absolute maximum ratings conditions for extended periods may affect device reliability.

Absolute Maximum Ratings

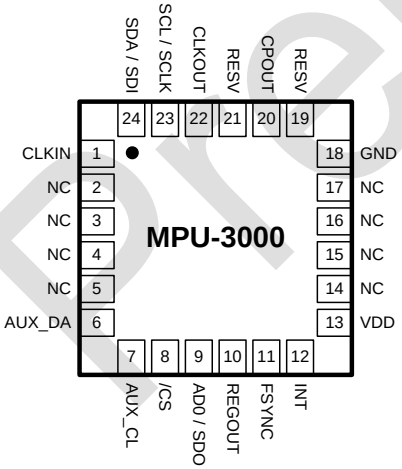
Parameter	Rating
Supply Voltage, VDD	-0.5V to +6V
VLOGIC Input Voltage Level (MPU-3050)	-0.5V to VDD + 0.5V
REGOUT	-0.5V to 2V
Input Voltage Level (CLKIN, AUX_DA, AD0, FSYNC, INT, SCL, SDA)	-0.5V to VDD + 0.5V
CPOUT (2.1V ≤ VDD ≤ 3.6V)	-0.5V to 30V
Acceleration (Any Axis, unpowered)	10,000*g* for 0.2ms
Operating Temperature Range	-40°C to +105°C
Storage Temperature Range	-40°C to +125°C
Electrostatic Discharge (ESD) Protection	1.5kV (HBM); 200V (MM)
Latch-up	JEDEC Class II (2),125°C Level B, ±60mA

Preliminary

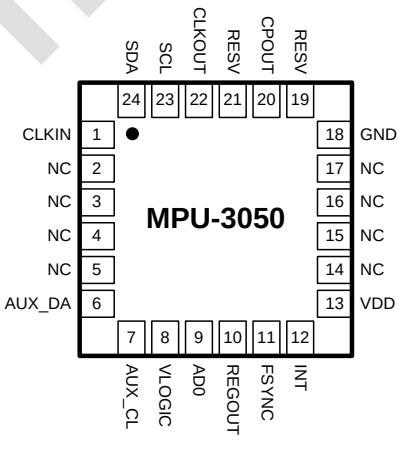
4 Applications Information

4.1 Pin Out and Signal Description

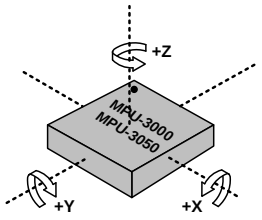
Pin Number	MPU-3000	MPU-3050	Pin Name	Pin Description
1	Y	Y	CLKIN	External reference clock input. Connect to GND if unused.
6	Y	Y	AUX_DA	Interface to a 3rd party accelerometer, SDA pin. Logic levels are set to be either VDD or VLOGIC. See Section 6 for more details.
7	Y	Y	AUX_CL	Interface to a 3rd party accelerometer, SCL pin. Logic levels are set to be either VDD or VLOGIC. See Section 6 for more details.
8	Y		/CS	SPI chip select (0=SPI mode, 1= I^2C mode)
8		Y	VLOGIC	Digital I/O supply voltage. VLOGIC must be ≤ VDD at all times.
9	Y		AD0 / SDO	I^2C Slave Address LSB (AD0); SPI serial data output (SDO)
9		Y	AD0	I^2C Slave Address LSB
10	Y	Y	REGOUT	Regulator filter capacitor connection
11	Y	Y	FSYNC	Frame synchronization digital input. Connect to GND if unused.
12	Y	Y	INT	Interrupt digital output (totem pole or open-drain)
13	Y	Y	VDD	Power supply voltage and Digital I/O supply voltage
18	Y	Y	GND	Power supply ground
19	Y	Y	RESV	Reserved. Do not connect.
20	Y	Y	CPOUT	Charge pump capacitor connection
21	Y	Y	RESV	Reserved. Do not connect.
22	Y	Y	CLKOUT	1MHz clock output for third-party accelerometer synchronization
23	Y		SCL / SCLK	I^2C serial clock (SCL); SPI serial clock (SCLK)
23		Y	SCL	I^2C serial clock
24	Y		SDA / SDI	I^2C serial data (SDA); SPI serial data input (SDI)
24		Y	SDA	I^2C serial data
2, 3, 4, 5, 14, 15, 16, 17	Y	Y	NC	Not internally connected. May be used for PCB trace routing.



QFN Package (Top View)
24-pin, 4mm x 4mm x 0.9mm



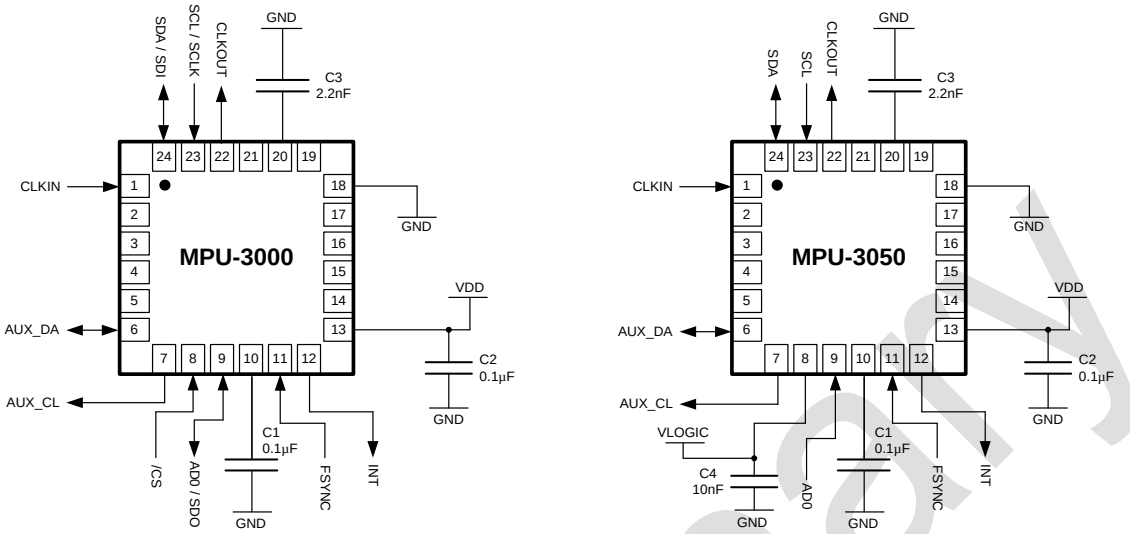
QFN Package (Top View)
24-pin, 4mm x 4mm x 0.9mm



Orientation of Axes of Sensitivity and Polarity of Rotation

Preliminary

4.2 Typical Operating Circuits



Typical Operating Circuits

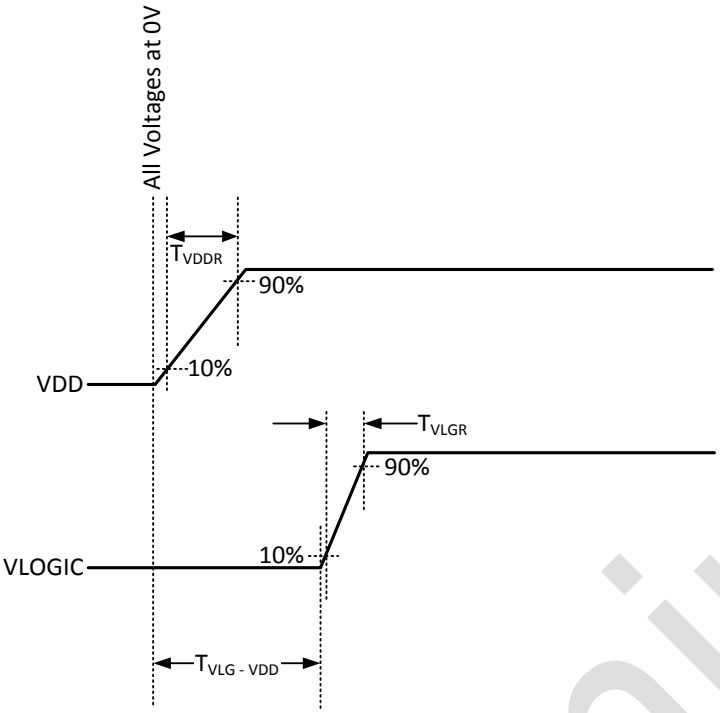
4.3 Bill of Materials for External Components

Component	Label	Specification	Quantity
Regulator Filter Capacitor	C1	Ceramic, X7R, 0.1µF ±10%, 2V	1
VDD Bypass Capacitor	C2	Ceramic, X7R, 0.1µF ±10%, 4V	1
Charge Pump Capacitor	C3	Ceramic, X7R, 2.2nF ±10%, 50V	1
VLOGIC Bypass Capacitor	C4*	Ceramic, X7R, 10nF ±10%, 4V	1

*MPU-3050 only

Preliminary

4.4 Recommended Power-on Procedure



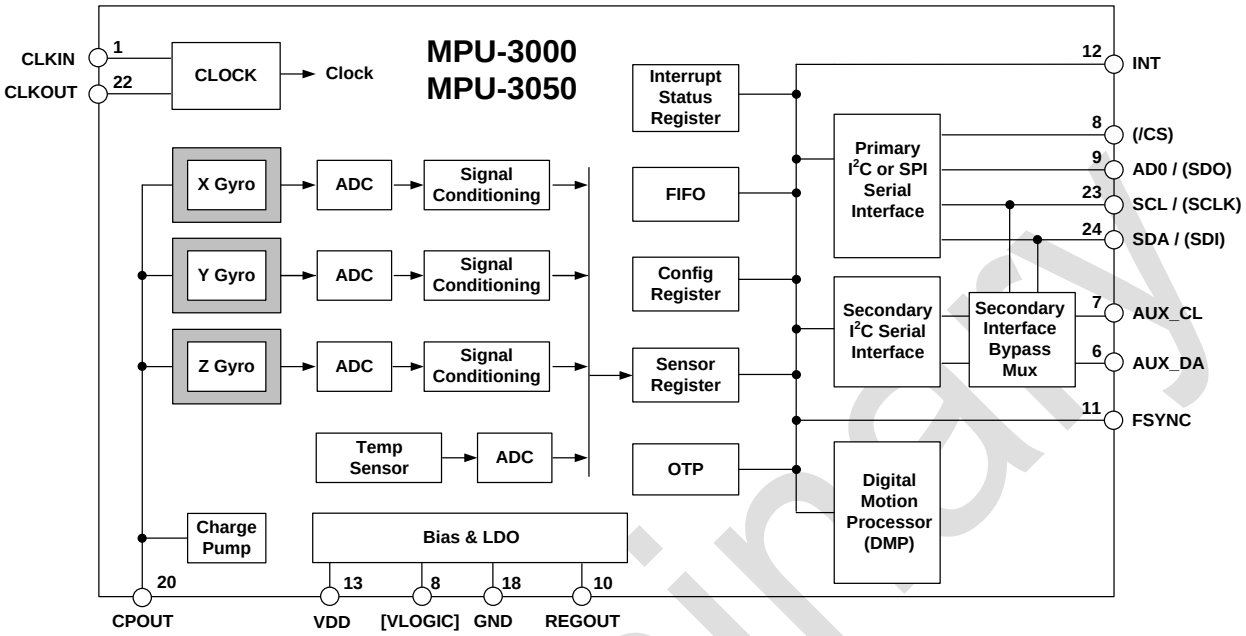
Power-Up Sequencing

1. VLOGIC amplitude must always be ≤VDD amplitude
2. T_{VDDR} is VDD rise time: Time for VDD to rise from 10% to 90% of its final value
3. T_{VDDR} is ≤5ms
4. T_{VLGR} is VLOGIC rise time: Time for VLOGIC to rise from 10% to 90% of its final value
5. T_{VLGR} is ≤1ms
6. $T_{VLG-VDD}$ is the delay from the start of VDD ramp to the start of VLOGIC rise
7. $T_{VLG-VDD}$ is ≥0ms;
8. VDD and VLOGIC must be monotonic ramps

Preliminary

5 Functional Overview

5.1 Block Diagram



Note: Pin names in round brackets ( ) are MPU-3000 only
Pin names in square brackets [ ] are MPU-3050 only

5.2 Overview

The MPU-30X0 is comprised of the following key blocks / functions:

- Three-axis MEMS rate gyroscope sensors with 16-bit ADCs and signal conditioning
- Digital Motion Processor (DMP)
- Primary I^2C and SPI (MPU-3000 only) serial communications interfaces
- Secondary I^2C serial interface for 3rd party accelerometer or other sensors
- Clocking
- Sensor Data Registers
- FIFO
- Interrupts
- Digital-Output Temperature Sensor
- Bias and LDO
- Charge Pump

5.3 Three-Axis MEMS Gyroscope with 16-bit ADCs and Signal Conditioning

The MPU-30X0 consists of three independent vibratory MEMS rate gyroscopes, which detect rotation about the X, Y, and Z axes. When the gyros are rotated about any of the sense axes, the Coriolis Effect causes a vibration that is detected by a capacitive pickoff. The resulting signal is amplified, demodulated, and filtered to produce a voltage that is proportional to the angular rate. This voltage is digitized using individual on-chip 16-bit Analog-to-Digital Converters (ADCs) to sample each axis. The full-scale range of the gyro sensors may be digitally programmed to ±250, ±500, ±1000, or ±2000 degrees per second (dps). ADC sample rate is programmable from 8,000 samples per second, down to 3.9 samples per second, and user-selectable low-pass filters enable a wide range of cut-off frequencies.

Preliminary

5.4 Digital Motion Processor

The embedded Digital Motion Processor (DMP) is located within the MPU-30X0 and offloads computation of motion processing algorithms from the host processor. The DMP acquires data from accelerometers, gyroscopes, and additional sensors such as magnetometers, and processes the data. The resulting data can be read from the DMP's registers, or can be buffered in a FIFO. The DMP has access to some of MPU's external pins, which can be used for synchronizing external devices to the motion sensors, or generating interrupts for the application.

The purpose of the DMP is to offload both timing requirements and processing power from the host processor. Typically, motion processing algorithms should be run at a high rate, often around 200Hz, in order to provide accurate results with low latency. This is required even if the application updates at a much lower rate; for example, a low power user interface may update as slowly as 5Hz, but the motion processing should still run at 200Hz. The DMP can be used as a tool in order to minimize power, simplify timing and software architecture, and save valuable MIPS on the host processor for use in the application.

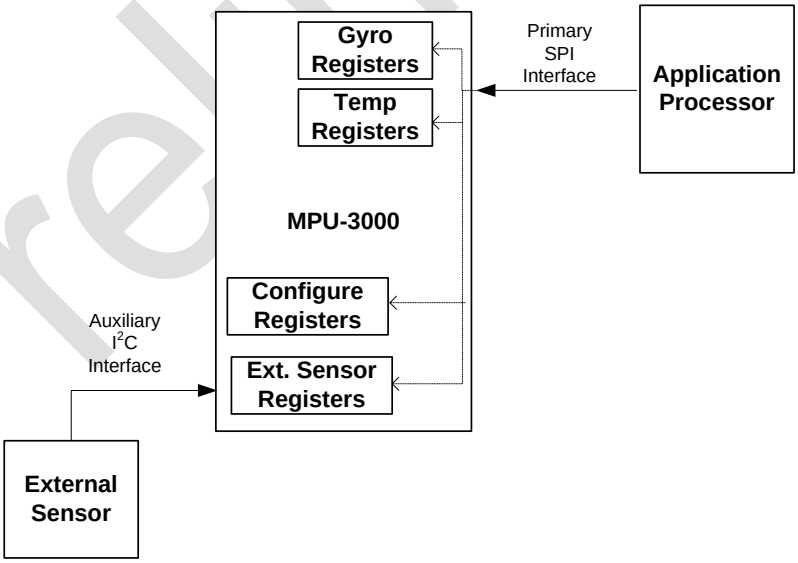
5.5 Primary I^2C and SPI Serial Communications Interfaces

The MPU-30X0 has a primary I^2C serial interface and the MPU-3000 also supports SPI protocol on the primary interface. SPI interface can be used to read/write to all the registers of MPU-3000 but the MPU's memory and FIFO are not accessible via the SPI interface. MPU-30X0 always acts as a slave when communicating to the system processor. The logic level for communications to the master is set by the voltage on the VLOGIC pin (MPU-3050) or by VDD (MPU-3000). The LSB of the of the I^2C slave address is set by pin 9 (AD0).

I^2C and SPI protocols are described in more detail in Section 6.

Note: When VDD is low, the primary I^2C or SPI (MPU-3000 only) interface pins become low impedance and thus can load the serial bus. This is a concern if other devices are active on the bus during this time.

SPI Usage Cases (MPU-3000 only):

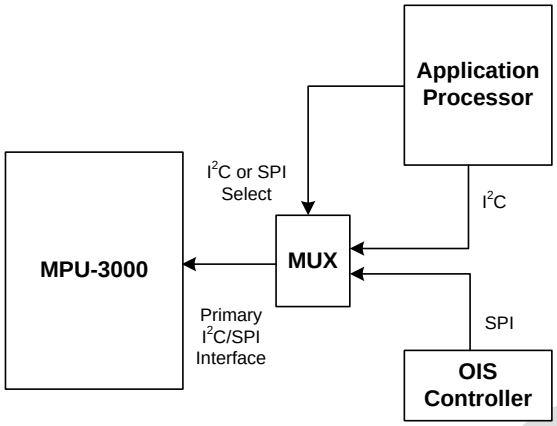


Accessing Raw Sensor Data and Configuring MPU-3000 using SPI interface

Primary interface on the MPU-3000 supports SPI protocol and this feature was designed in keeping in mind high speed applications which need access to raw sensor data. As depicted in the above diagram all the

Preliminary

sensor registers can be accessed using the SPI interface and the MPU-3000 can be configured through the SPI interface. MPU's memory and FIFO are not accessible via the SPI interface.



Dual Mode Operation Using SPI

The MPU-3000's SPI interface can also be used in a dual-mode configuration as shown above. In this configuration, the application processor accesses all the functions of MPU-3000 using the I^2C interface of the MPU-3000, and the OIS controller accesses only raw data from the MPU-3000 gyroscope registers using the SPI interface. The multiplexer (MUX) is used to select which interface device is connected to the primary serial interface of the MPU-3000. The figure above is simplified, since there needs to be communication between the application processor and the OIS controller, and this is not shown.

5.6 Secondary I^2C Serial Interface (for a third-party Accelerometer or other sensors)

The MPU-30X0 has a secondary I^2C bus for communicating to an off-chip 3-axis digital output accelerometer. This bus has two operating modes: I^2C Master Mode, where the MPU-30X0 acts as a master to an external accelerometer connected to the secondary I^2C bus; and Pass-Through Mode, where the MPU-30X0 directly connects the primary and secondary I^2C buses together, to allow the system processor to directly communicate with the external accelerometer.

Secondary I^2C Bus Modes of Operation:

- I^2C Master Mode: allows the MPU-30X0 to directly access the data registers of an external digital accelerometer. In this mode, the MPU-30X0 directly obtains sensor data from accelerometers and optionally, another sensor (such as a magnetometer), thus allowing the on-chip DMP to generate sensor fusion data without intervention from the system applications processor. In I^2C master mode, the MPU-30X0 can be configured to perform burst reads, returning the following data from the accelerometer:
  - X accelerometer data (2 bytes)
  - Y accelerometer data (2 bytes)
  - Z accelerometer data (2 bytes)

- Pass-Through Mode: allows an external system processor to act as master and directly communicate to the external accelerometer connected to the secondary I^2C bus pins (AUX_DA and AUX_CL). This is useful for configuring the accelerometers, or for keeping the MPU-30X0 in a low-power mode, when only accelerometers are to be used. In this mode, the secondary I^2C bus control logic (third-party accelerometer Interface block) of the MPU-30X0 is disabled, and the secondary I^2C pins AUX_DA and AUX_CL (Pins 6 and 7) are connected to the main I^2C bus (Pins 23 and 24) through analog switches.

  In the Pass-Through Mode the system processor can still access MPU-30X0 gyro data through the I^2C interface.

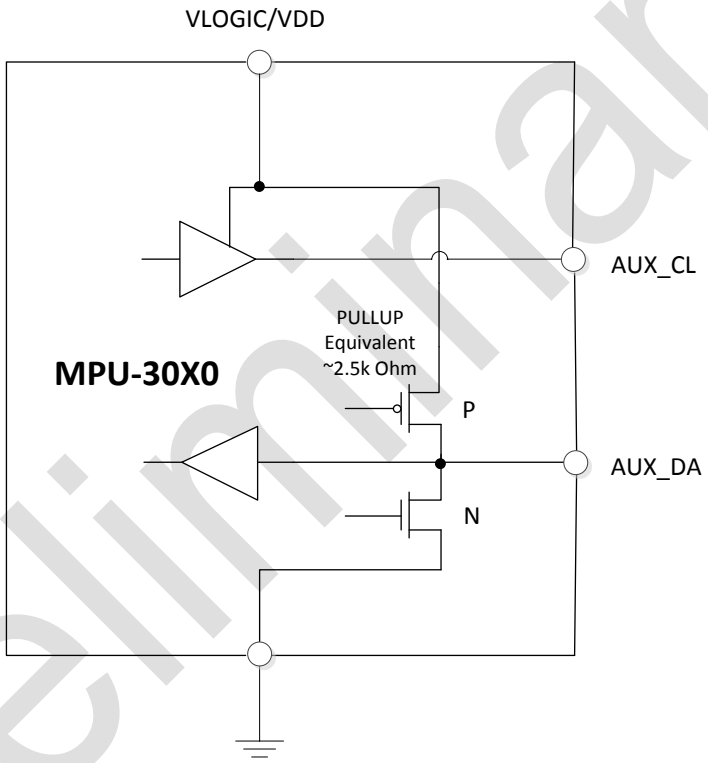
Preliminary

Secondary I²C Bus IO Logic Levels

The logic levels of the secondary I²C bus can be programmed to be either VDD or VLOGIC (see Sections 6 and 7).

Secondary I²C Bus Internal Pull-up Configuration

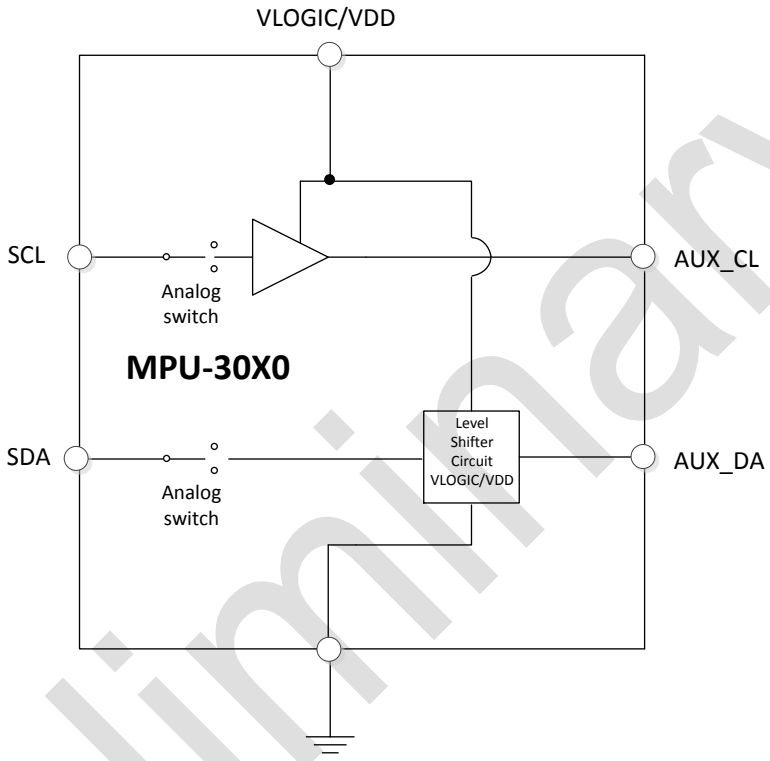
- I²C Master Mode Equivalent Circuit: The simplified equivalent circuit diagram below shows the MPU-30X0 auxiliary I²C interface while in master mode. It should be noted that the AUX_CL pin is output only and is driven by a CMOS output buffer which does not require a pull-up resistor. The AUX_DA pin is open drain and an internal pull-up resistor is enabled. The CMOS output buffer and the pull up resistor can be powered from VDD or VLOGIC. Please refer to Section 7.2 for more details.



MPU-30X0 I²C Master Mode Auxiliary I²C interface – equivalent circuit

Preliminary

- Pass-Through Mode – Equivalent Circuit: The simplified equivalent circuit diagram below shows the MPU-30X0 I²C interface during pass-through mode. Internal analog switches are used to connect the primary and auxiliary I²C interfaces together (SCL to AUX_CL through a buffer and SDA to AUX_DA pins through a level shifter).



MPU-30X0 Pass-Through Mode Equivalent Circuit

5.7 Internal Clock Generation

The MPU-30X0 has a flexible clocking scheme, allowing for a variety of internal or external clock sources for the internal synchronous circuitry. This synchronous circuitry includes the signal conditioning and ADCs, the DMP, and various control circuits and registers. An on-chip PLL provides flexibility in the allowable inputs for generating this clock.

Allowable internal sources for generating the internal clock are:

- An internal relaxation oscillator
- Any of the X, Y, or Z gyros (MEMS oscillators with a drift of ±1% over temperature)

Allowable external clocking sources are:

- 32.768kHz square wave
- 19.2MHz square wave

The choice of which source to select for generating the internal synchronous clock depends on the availability of external sources and the requirements for power consumption and clock accuracy. Most likely, these requirements will vary by mode of operation. For example, in one mode, where the biggest concern is power consumption, one may wish to operate the Digital Motion Processor of the MPU-30X0 to process

Preliminary

accelerometer data, while keeping the gyros off. In this case, the internal relaxation oscillator is a good clock choice. However, in another mode, where the gyros are active, selecting the gyros as the clock source provides for a more-accurate clock source.

Clock accuracy is important, since timing errors directly affect the distance and angle calculations performed by the Digital Motion Processor (or by extension, by any processor).

There are also start-up conditions to consider. When the MPU-30X0 initially starts up; the device operates off of its internal clock until programmed to operate from another source. This allows the user, for example, to wait for the MEMS oscillators to stabilize before they are selected as the clock source.

5.8 Clock Output

In addition, the MPU-30X0 provides a clock output, which allows the device to operate synchronously with an external digital 3-axis accelerometer. Operating synchronously provides for higher-quality sensor fusion data, since the sampling instant for the sensor data can be set to be coincident for all sensors.

5.9 Sensor Data Registers

The sensor data registers contain the latest gyro and temperature data. They are read-only registers, and are accessed via the Serial Interface. Data from these registers may be read anytime, however, the interrupt function may be used to determine when new data is available.

5.10 FIFO

The MPU-30X0 contains a 512-byte FIFO register that is accessible via the Serial Interface. The FIFO configuration register determines what data goes into it, with possible choices being gyro data, accelerometer data, temperature readings, auxiliary ADC readings, and FSYNC input. A FIFO counter keeps track of how many bytes of valid data are contained in the FIFO. The FIFO register supports burst reads. The interrupt function may be used to determine when new data is available.

5.11 Interrupts

Interrupt functionality is configured via the Interrupt Configuration register. Items that are configurable include the INT pin configuration, the interrupt latching and clearing method, and triggers for the interrupt. Items that can trigger an interrupt are (1) Clock generator locked to new reference oscillator (used when switching clock sources); (2) Digital Motion Processor Done (programmable function); (3) new data is available to be read (from the FIFO and Data registers); and (4) the MPU-30X0 did not receive an acknowledge from the accelerometer on the Secondary I^2C bus. The interrupt status can be read from the Interrupt Status register.

5.12 Digital-Output Temperature Sensor

An on-chip temperature sensor and ADC are used to measure the MPU-30X0 die temperature. The readings from the ADC can be read from the FIFO or the Sensor Data registers.

5.13 Bias and LDO

The bias and LDO section generates the internal supply and the reference voltages and currents required by the MPU-30X0. Its two inputs are an unregulated VDD of 2.1V to 3.6V and a VLOGIC logic reference supply voltage of 1.71V to VDD (MPU-3050 only). The LDO output is bypassed by a 0.1µF capacitor at REGOUT.

5.14 Charge Pump

An on-board charge pump generates the high voltage required for the MEMS oscillators. Its output is bypassed by a 2.2nF capacitor at CPOUT.

5.15 Chip Version

The chip version is written into OTP memory.

Preliminary

6 Digital Interface

6.1 I²C and SPI (MPU-3000 only) Serial Interfaces

The internal registers and memory of the MPU-3000/MPU-3050 can be accessed using either I²C or SPI (MPU-3000 & raw sensor data only). SPI operates in four-wire mode.

Serial Interface

Pin Number	MPU-3000	MPU-3050	Pin Name	Pin Description
8	Y		/CS	SPI chip select (0=SPI mode, I²C disable, 1= I²C mode, SPI disable)
8		Y	VLOGIC	Digital I/O supply voltage. VLOGIC must be ≤ VDD at all times.
9	Y		AD0 / SDO	I²C Slave Address LSB (AD0); SPI serial data output (SDO)
9		Y	AD0	I²C Slave Address LSB
23	Y		SCL / SCLK	I²C serial clock (SCL); SPI serial clock (SCLK)
23		Y	SCL	I²C serial clock
24	Y		SDA / SDI	I²C serial data (SDA); SPI serial data input (SDI)
24		Y	SDA	I²C serial data

Note 1:
To prevent switching into I²C mode when using SPI (MPU-3000), the I²C interface should be disabled by setting the *I2C_IF_DIS* configuration bit in the WHO_AM_I register. Setting this bit should be performed immediately after waiting the time specified by the "Start-Up Time for Register Read/Write" in Section 3.2.

6.1.1 I²C Interface

I²C is a two-wire interface comprised of the signals serial data (SDA) and serial clock (SCL). In general, the lines are open-drain and bi-directional. In a generalized I²C interface implementation, attached devices can be a master or a slave. The master device puts the slave address on the bus, and the slave device with the matching address acknowledges the master.

The MPU-30X0 always operates as a slave device when communicating to the system processor, which thus acts as the master. SDA and SCL lines typically need pull-up resistors to VDD. The maximum bus speed is 400kHz.

The slave address of the MPU-30X0 is b110100X which is 7 bits long. The LSB bit of the 7 bit address is determined by the logic level on pin ADO. This allows two MPU-30X0s to be connected to the same I²C bus. When used in this configuration, the address of the one of the devices should be b1101000 (pin ADO is logic low) and the address of the other should be b1101001 (pin AD0 is logic high). The I²C address is stored in WHO_AM_I register.

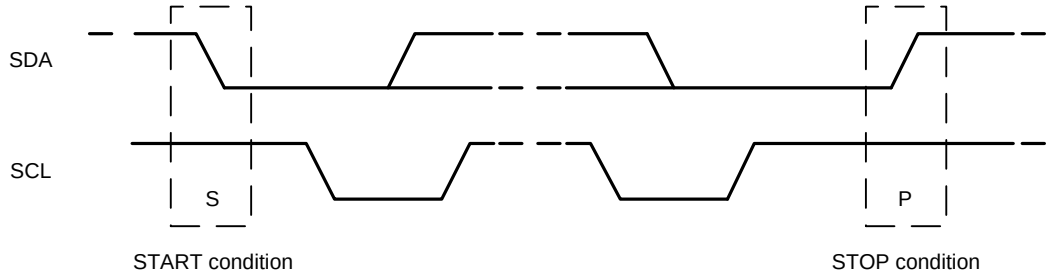
I²C Communications Protocol

START (S) and STOP (P) Conditions

Communication on the I²C bus starts when the master puts the START condition (S) on the bus, which is defined as a HIGH-to-LOW transition of the SDA line while SCL line is HIGH (see figure below). The bus is considered to be busy until the master puts a STOP condition (P) on the bus, which is defined as a LOW to HIGH transition on the SDA line while SCL is HIGH (see figure below).

Additionally, the bus remains busy if a repeated START (Sr) is generated instead of a STOP condition.

Preliminary

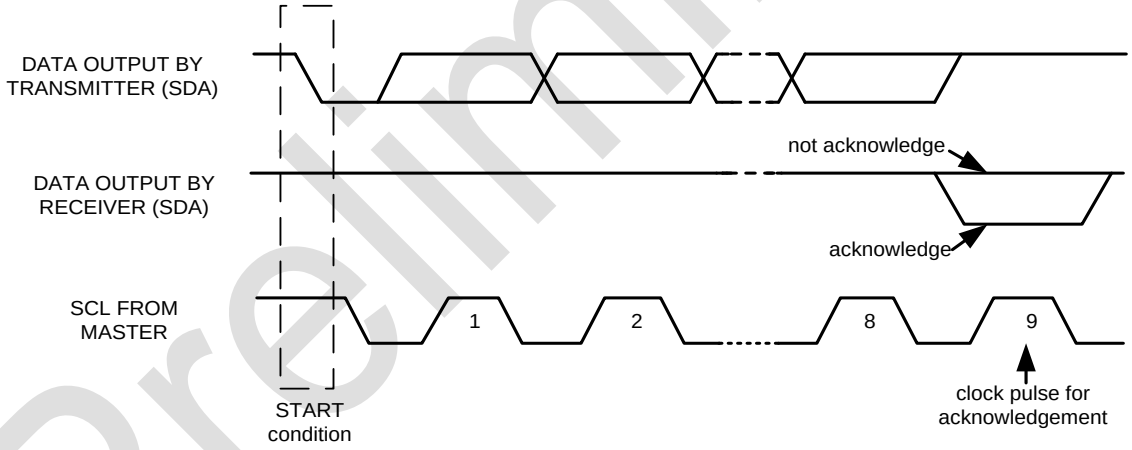


START and STOP Conditions

Data Format / Acknowledge

I²C data bytes are defined to be 8 bits long. There is no restriction to the number of bytes transmitted per data transfer. Each byte transferred must be followed by an acknowledge (ACK) signal. The clock for the acknowledge signal is generated by the master, while the receiver generates the actual acknowledge signal by pulling down SDA and holding it low during the HIGH portion of the acknowledge clock pulse.

If a slave is busy and is unable to transmit or receive another byte of data until some other task has been performed, it can hold SCL LOW, thus forcing the master into a wait state. Normal data transfer resumes when the slave is ready, and releases the clock line (refer to the following figure).

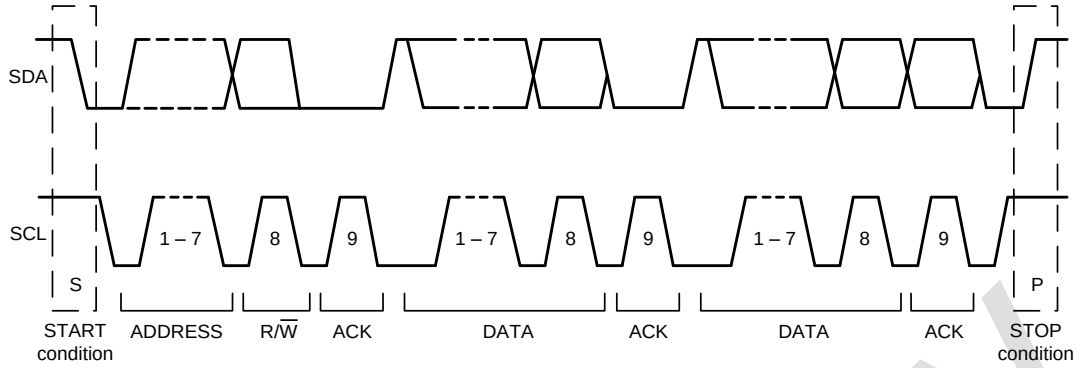


Acknowledge on the I²C Bus

Communications

After beginning communications with the START condition (S), the master sends a 7-bit slave address followed by an 8th bit, the read/write bit. The read/write bit indicates whether the master is receiving data from or is writing to the slave device. Then, the master releases the SDA line and waits for the acknowledge signal (ACK) from the slave device. Each byte transferred must be followed by an acknowledge bit. To acknowledge, the slave device pulls the SDA line LOW and keeps it LOW for the high period of the SCL line. Data transmission is always terminated by the master with a STOP condition (P), thus freeing the communications line. However, the master can generate a repeated START condition (Sr), and address another slave without first generating a STOP condition (P). A LOW to HIGH transition on the SDA line while SCL is HIGH defines the stop condition. All SDA changes should take place when SCL is low, with the exception of start and stop conditions.

Preliminary



Complete I²C Data Transfer

To write the internal MPU-30X0 registers, the master transmits the start condition (S), followed by the I²C address and the write bit (0). At the 9th clock cycle (when the clock is high), the MPU-30X0 acknowledges the transfer. Then the master puts the register address (RA) on the bus. After the MPU-30X0 acknowledges the reception of the register address, the master puts the register data onto the bus. This is followed by the ACK signal, and data transfer may be concluded by the stop condition (P). To write multiple bytes after the last ACK signal, the master can continue outputting data rather than transmitting a stop signal. In this case, the MPU-30X0 automatically increments the register address and loads the data to the appropriate register. The following figures show single and two-byte write sequences.

Single-Byte Write Sequence

Master	S	AD+W		RA		DATA		P
Slave			ACK		ACK		ACK	

Burst Write Sequence

Master	S	AD+W		RA		DATA		DATA		P
Slave			ACK		ACK		ACK		ACK	

To read the internal MPU-30X0 registers, the master sends a start condition, followed by the I²C address and a write bit, and then the register address that is going to be read. Upon receiving the ACK signal from the MPU-30X0, the master transmits a start signal followed by the slave address and read bit. As a result, the MPU-30X0 sends an ACK signal and the data. The communication ends with a not acknowledge (NACK) signal and a stop bit from master. The NACK condition is defined such that the SDA line remains high at the 9th clock cycle. The following figures show single and two-byte read sequences.

Single-Byte Read Sequence

Master	S	AD+W		RA		S	AD+R			NACK	P
Slave			ACK		ACK			ACK	DATA		

Burst Read Sequence

Master	S	AD+W		RA		S	AD+R			ACK		NACK	P
Slave			ACK		ACK			ACK	DATA		DATA		

Preliminary

I²C Terms

Signal	Description
S	Start Condition: SDA goes from high to low while SCL is high
AD	Slave I²C address
W	Write bit (0)
R	Read bit (1)
ACK	Acknowledge: SDA line is low while the SCL line is high at the 9th clock cycle
NACK	Not-Acknowledge: SDA line stays high at the 9th clock cycle
RA	MPU-30X0 internal register address
DATA	Transmit or received data
P	Stop condition: SDA going from low to high while SCL is high

Preliminary

6.1.2 SPI interface (MPU-3000 only)

SPI is a 4-wire synchronous serial interface that uses two control and two data lines. The MPU-3000 always operates as a Slave device during standard Master-Slave SPI operation. With respect to the Master, the Serial Clock output (SCLK), the Data Output (SDO) and the Data Input (SDI) are shared among the Slave devices. The Master generates an independent Chip Select (/CS) for each Slave device; /CS goes low at the start of transmission and goes back high at the end. The Serial Data Output (SDO) line, remains in a high-impedance (high-z) state when the device is not selected, so it does not interfere with any active devices.

SPI Operational Features

1. Data is delivered MSB first and LSB last
2. Data is latched on rising edge of SCLK
3. Data should be transitioned on the falling edge of SCLK
4. SCLK frequency is 1MHz max
5. SPI read and write operations are completed in 16 or more clock cycles (two or more bytes). The first byte contains the SPI Address, and the following byte(s) contain(s) the SPI data. The first bit of the first byte contains the Read/Write bit and indicates the Read (1) or Write (0) operation. The following 7 bits contain the Register Address. In cases of multiple-byte Read/Writes, data is two or more bytes:

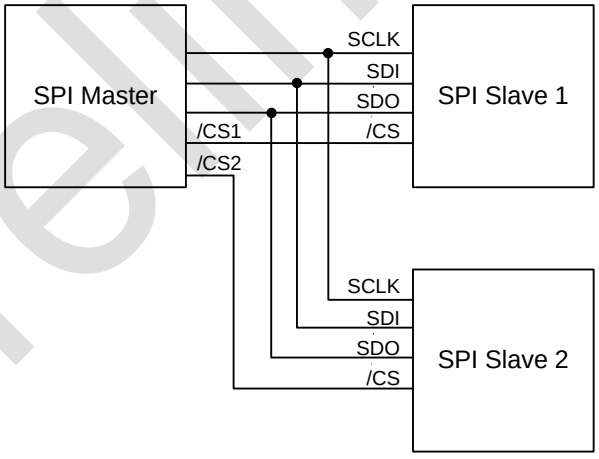
SPI Address format

MSB							**LSB**
R/W	A6	A5	A4	A3	A2	A1	A0

SPI Data format

MSB							**LSB**
D7	D6	D5	D4	D3	D2	D1	D0

6. Supports Single or Burst Read/Writes.



Typical SPI Master / Slave Configuration

Each SPI slave requires its own Chip Select (/CS) line. SDO, SDI and SCLK lines are shared. Only one /CS line is active (low) at a time ensuring that only one slave is selected at a time. The /CS lines of other slaves are held high which causes their respective SDO pins to be high-Z.

Preliminary

7 Serial Interface Considerations (MPU-3050)

7.1 MPU-3050 Supported Interfaces

The MPU-3050 supports I^2C communications on both its primary (microprocessor) serial interface and its secondary (accelerometer) interface.

7.2 Logic Levels

The MPU-3050 I/O logic levels are set to be either VDD or VLOGIC, as shown in the table below.

I/O Logic Levels vs. *AUX_VDDIO* (Secondary I^2C Bus IO Level)

AUX_VDDIO	**MICROPROCESSOR LOGIC LEVELS** (Pins: SDA, SCL, AD0,CLKIN, INT)	**ACCELEROMETER LOGIC LEVELS** (Pins: AUX_DA, AUX_CL)
0	VLOGIC	VLOGIC
1	VLOGIC	VDD

Notes:

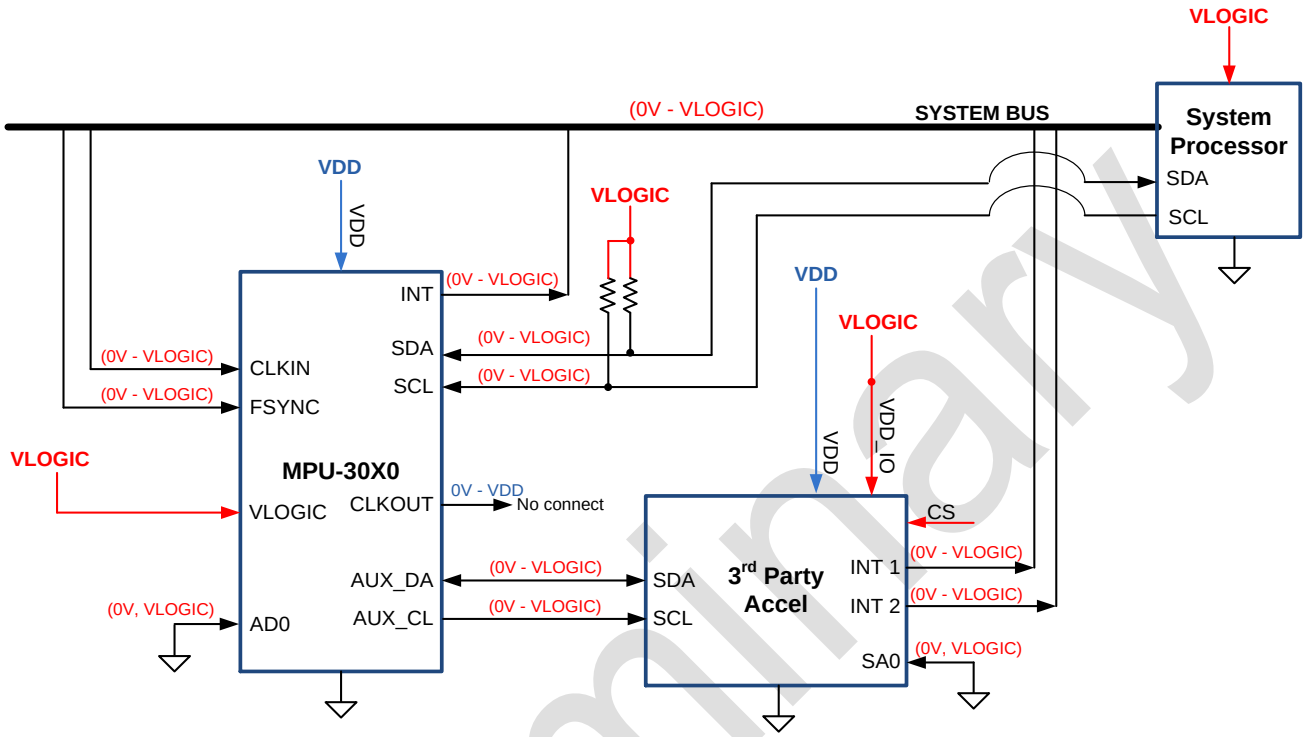
1. CLKOUT has logic levels that are always referenced to VDD
2. The power-on-reset value for *AUX_VDDIO* is 0.

VLOGIC may be set to be equal to VDD or to another voltage, such that at all times VLOGIC is ≤ VDD. When *AUX_VDDIO* is set to 0 (its power-on-reset value), VLOGIC is the power supply voltage for both the microprocessor system bus and the accelerometer secondary bus, as shown in the figure of Section 7.2.1. When *AUX_VDDIO* is set to 1, VLOGIC is the power supply voltage for the microprocessor system bus and VDD is the supply for the accelerometer secondary bus, as shown in the figure of Section 7.2.2.

Preliminary

7.2.1 AUX_VDDIO = 0

The figure below shows logic levels and voltage connections for AUX_VDDIO = 0. Note: Actual configuration will depend on the type of third-party accelerometer used.



Notes:

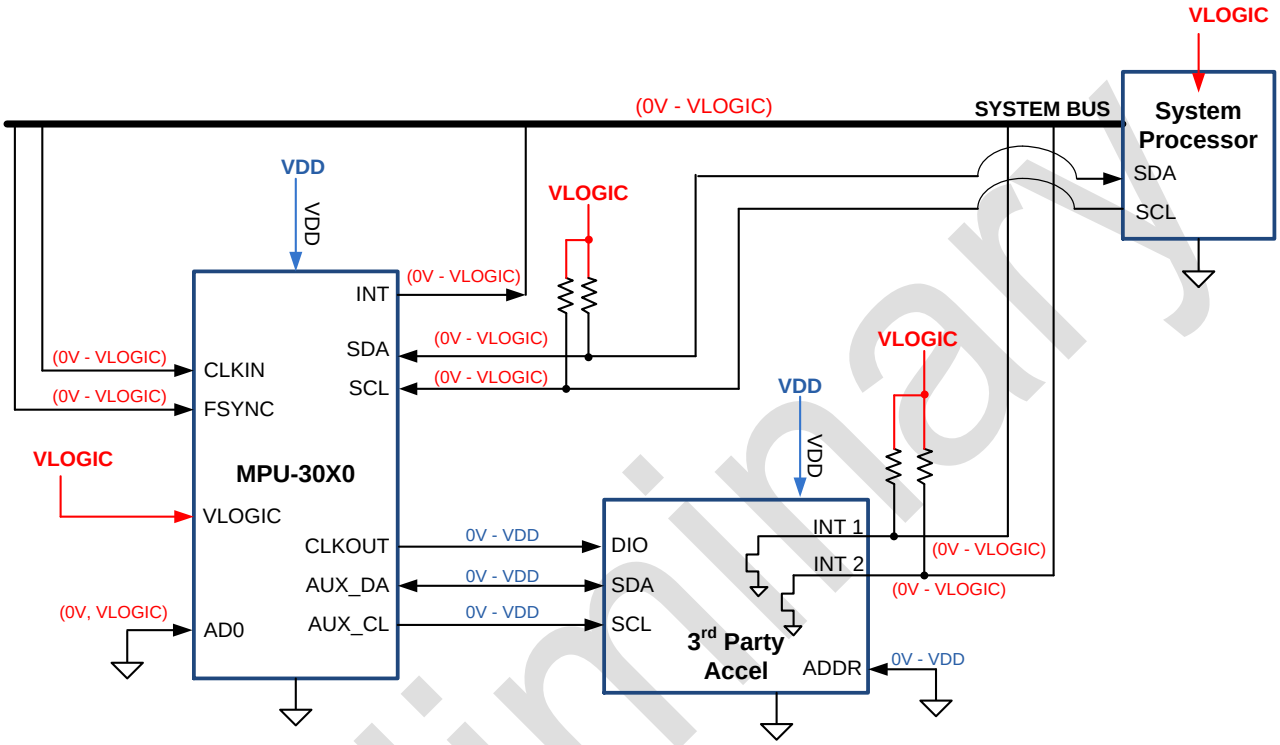
1. AUX_VDDIO is bit 7 in Register 24, and determines the IO voltage levels of AUX_DA and AUX_CL (0 = set output levels relative to VLOGIC)
2. CLKOUT is always referenced to VDD
3. Other MPU-3050 logic IO are always referenced to VLOGIC

I/O Levels and Connections for *AUX_VDDIO* = 0

Preliminary

7.2.2 AUX_VDDIO = 1

When *AUX_VDDIO* is set to 1 by the user, VLOGIC is the power supply voltage for the microprocessor system bus and VDD is the power supply for the accelerometer secondary bus, as shown in the figure below. This is useful when interfacing to a third-party accelerometer where there is only one supply for both the logic and analog sections of the 3rd party accelerometer.



Voltage/ Configuration	Configuration 1	Configuration 2
VLOGIC	1.8V±5%	3.0V±5%
VDD	2.5V±5%	3.0V±5%
AUX_VDDIO	1	1

Notes:

1. AUX_VDDIO is bit 7 in Register 24, and determines the IO voltage levels of AUX_DA and AUX_CL (1 = set output levels relative to VDD)
2. CLKOUT is always referenced to VDD
3. Other MPU-3050 logic IO are always referenced to VLOGIC
4. Third-party accelerometer logic levels are referenced to VDD; setting INT1 and INT2 to open-drain configuration provides voltage compatibility when VDD ≠ VLOGIC.
   When VDD = VLOGIC, INT1 and INT2 may be set to push-pull outputs, and the external pull-up resistors will not be needed.

I/O Levels and Connections for Two Example Power Configurations (*AUX_VDDIO* = 1)

Note: Actual configuration will depend on the type of third-party accelerometer used.

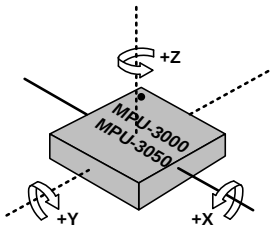
Preliminary

8 Assembly

This section provides general guidelines for assembling InvenSense Micro Electro-Mechanical Systems (MEMS) gyros packaged in Quad Flat No leads package (QFN) surface mount integrated circuits.

8.1 Orientation of Axes

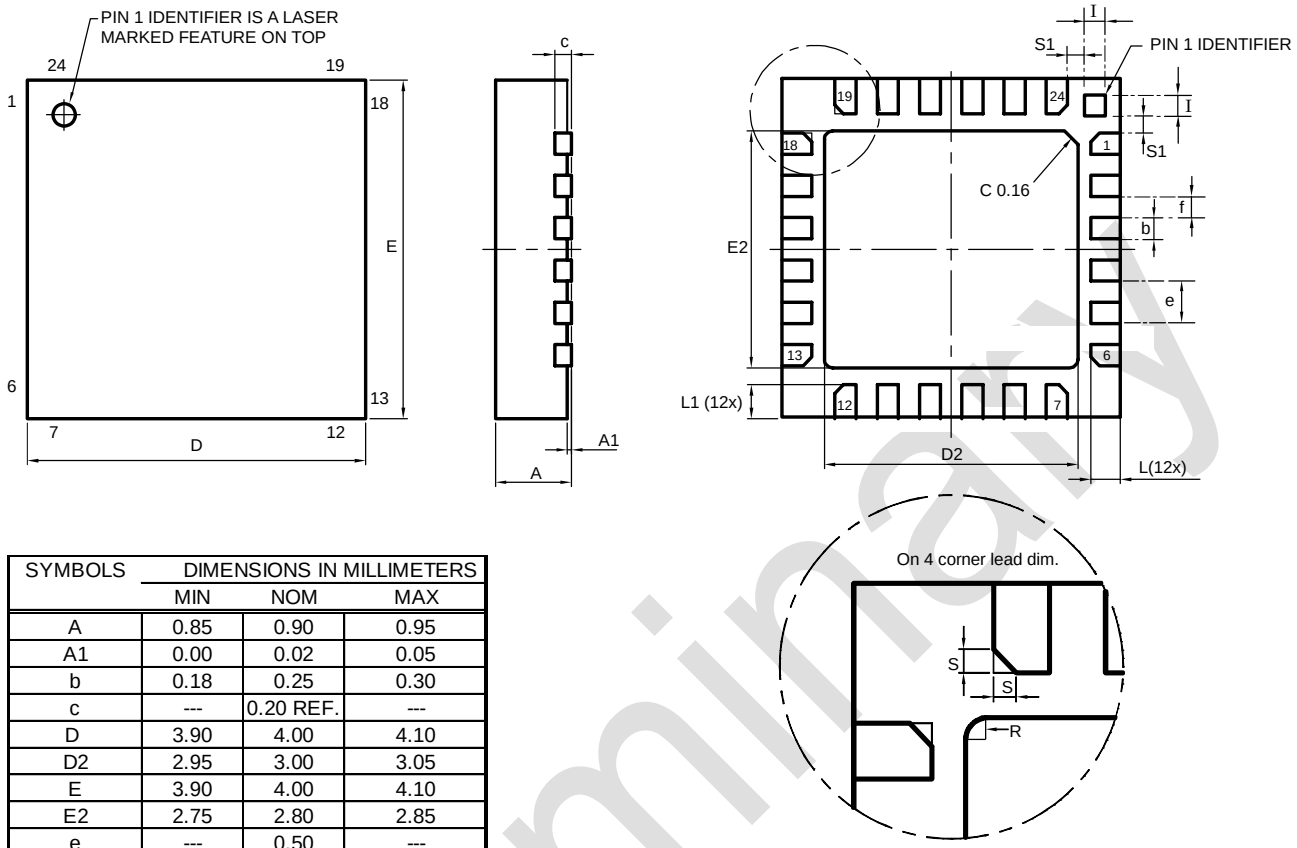
The diagram below shows the orientation of the axes of sensitivity and the polarity of rotation. Note the pin 1 identifier in the figure.



Orientation of Axes of Sensitivity and Polarity of Rotation

Preliminary

8.2 Package Dimensions:

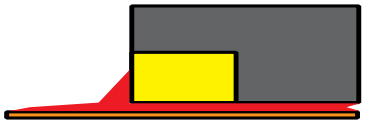


SYMBOLS	DIMENSIONS IN MILLIMETERS		
	MIN	NOM	MAX
A	0.85	0.90	0.95
A1	0.00	0.02	0.05
b	0.18	0.25	0.30
c	---	0.20 REF.	---
D	3.90	4.00	4.10
D2	2.95	3.00	3.05
E	3.90	4.00	4.10
E2	2.75	2.80	2.85
e	---	0.50	---
f (e-b)	0.20	0.25	0.32
L	0.30	0.35	0.40
L1	0.35	0.40	0.45
I	0.20	0.25	0.30
R	0.05	---	0.10
s	0.05	---	0.15
S1	0.15	0.20	0.25

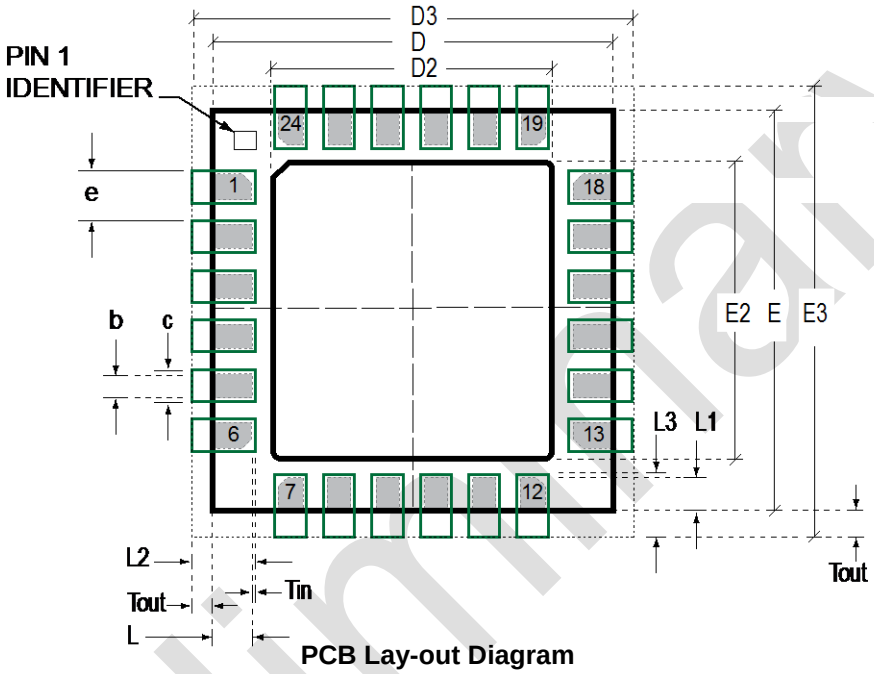
Preliminary

8.3 PCB Design Guidelines:

The Pad Diagram using a JEDEC type extension with solder rising on the outer edge is shown below. The Pad Dimensions Table shows pad sizing (mean dimensions) recommended for the MPU-30X0 product.



JEDEC type extension with solder rising on outer edge



PCB Lay-out Diagram

SYMBOLS	DIMENSIONS IN MILLIMETERS	NOM
Nominal Package I/O Pad Dimensions		
e	Pad Pitch	0.50
b	Pad Width	0.25
L	Pad Length	0.35
L1	Pad Length	0.40
D	Package Width	4.00
E	Package Length	4.00
D2	Exposed Pad Width	3.00
E2	Exposed Pad Length	2.80
I/O Land Design Dimensions (Guidelines)		
D3	I/O Pad Extent Width	4.80
E3	I/O Pad Extent Length	4.80
c	Land Width	0.35
Tout	Outward Extension	0.40
Tin	Inward Extension	0.05
L2	Land Length	0.80
L3	Land Length	0.85

PCB Dimensions Table (for PCB Lay-out Diagram)

Preliminary

8.4 Assembly Precautions

8.4.1 Gyroscope Surface Mount Guidelines

InvenSense MEMS Gyros sense rate of rotation. In addition, gyroscopes sense mechanical stress coming from the printed circuit board (PCB). This PCB stress can be minimized by adhering to certain design rules:

When using MEMS gyroscope components in plastic packages, PCB mounting and assembly can cause package stress. This package stress in turn can affect the output offset and its value over a wide range of temperatures. This stress is caused by the mismatch between the Coefficient of Linear Thermal Expansion (CTE) of the package material and the PCB. Care must be taken to avoid package stress due to mounting.

Traces connected to pads should be as symmetric as possible. Maximizing symmetry and balance for pad connection will help component self alignment and will lead to better control of solder paste reduction after reflow.

Any material used in the surface mount assembly process of the MEMS gyroscope should be free of restricted RoHS elements or compounds. Pb-free solders should be used for assembly.

8.4.2 Exposed Die Pad Precautions

The MPU-30X0 has very low active and standby current consumption. The exposed die pad is not required for heat sinking, and should not be soldered to the PCB. Failure to adhere to this rule can induce performance changes due to package thermo-mechanical stress. There is no electrical connection between the pad and the CMOS.

8.4.3 Trace Routing

Routing traces or vias under the gyro package such that they run under the exposed die pad is prohibited. Routed active signals may harmonically couple with the gyro MEMS devices, compromising gyro response. These devices are designed with the drive frequencies as follows: X = 33±3kHz, Y = 30±3kHz, and Z=27±3kHz. To avoid harmonic coupling don't route active signals in non-shielded signal planes directly below, or above the gyro package. Note: For best performance, design a ground plane under the e-pad to reduce PCB signal noise from the board on which the gyro device is mounted. If the gyro device is stacked under an adjacent PCB board, design a ground plane directly above the gyro device to shield active signals from the adjacent PCB board.

8.4.4 Component Placement

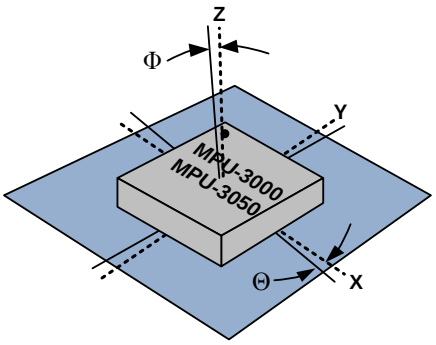
Do not place large insertion components such as keyboard or similar buttons, connectors, or shielding boxes at a distance of less than 6 mm from the MEMS gyro. Maintain generally accepted industry design practices for component placement near the MPU-30X0 to prevent noise coupling and thermo-mechanical stress.

8.4.5 PCB Mounting and Cross-Axis Sensitivity

Orientation errors of the gyroscope mounted to the printed circuit board can cause cross-axis sensitivity in which one gyro responds to rotation about another axis. For example, the X-axis gyroscope may respond to rotation about the Y or Z axes. The orientation mounting errors are illustrated in the figure below.

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Preliminary



Package Gyro Axes (– – –) Relative to PCB Axes (——) with Orientation Errors (Θ and Φ)

The table below shows the cross-axis sensitivity of the gyroscope for a given orientation error.

Cross-Axis Sensitivity vs. Orientation Error

Orientation Error (θ or Φ)	Cross-Axis Sensitivity (sinθ or sinΦ)
0º	0%
0.5º	0.87%
1º	1.75%

The specification for cross-axis sensitivity in Section 3.1 includes the effect of the die orientation error with respect to the package.

8.4.6 MEMS Handling Instructions

MEMS (Micro Electro-Mechanical Systems) are a time-proven, robust technology used in hundreds of millions of consumer, automotive and industrial products. MEMS devices consist of microscopic moving mechanical structures. They differ from conventional IC products, even though they can be found in similar packages. Therefore, MEMS devices require different handling precautions than conventional ICs prior to mounting onto printed circuit boards (PCBs).

The MPU-30X0 gyroscope has been qualified to a shock tolerance of 10,000*g*. InvenSense packages its gyroscopes as it deems proper for protection against normal handling and shipping. It recommends the following handling precautions to prevent potential damage.

- Do not drop individually packaged gyroscopes, or trays of gyroscopes onto hard surfaces. Components placed in trays could be subject to *g*-forces in excess of 10,000*g* if dropped.
- Printed circuit boards that incorporate mounted gyroscopes should not be separated by manually snapping apart. This could also create *g*-forces in excess of 10,000*g.*

8.4.7 ESD Considerations

Establish and use ESD-safe handling precautions when unpacking and handling ESD-sensitive devices.

- Store ESD sensitive devices in ESD safe containers until ready for use. The Tape-and-Reel moisture-sealed bag is an ESD approved barrier. The best practice is to keep the units in the original moisture sealed bags until ready for assembly.
- Restrict all device handling to ESD protected work areas that measure less than 200V static charge. Ensure that all workstations and personnel are properly grounded to prevent ESD.

Preliminary

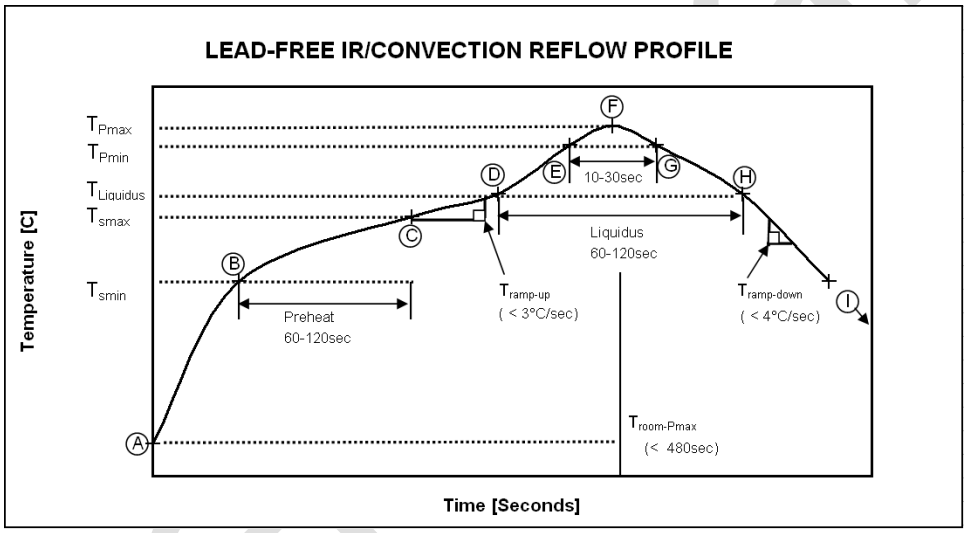
8.4.8 Reflow Specification

Qualification Reflow: The MPU-30X0 gyroscope was qualified in accordance with IPC/JEDEC J-STD-020D.01. This standard classifies proper packaging, storage and handling in order to avoid subsequent thermal and mechanical damage during the solder reflow attachment phase of assembly. The classification specifies a sequence consisting of a bake cycle, a moisture soak cycle in a temperature humidity oven, followed by three solder reflow cycles and functional testing for qualification. All temperatures refer to the topside of the QFN package, as measured on the package body surface. The peak solder reflow classification temperature requirement is (260 +5/-0°C) for lead-free soldering of components measuring less than 1.6 mm in thickness.

Production Reflow: Check the recommendations of your solder manufacturer. For optimum results, production solder reflow processes should reduce exposure to high temperatures, and use lower ramp-up and ramp-down rates than those used in the component qualification profile shown for reference below.

Production reflow should never exceed the maximum constraints listed in the table and shown in the figure below. These constraints were used for the qualification profile, and represent the maximum tolerable ratings for the device.

Maximum Temperature IR / Convection Solder Reflow Curve Used for Qualification



Temperature Set Points for IR / Convection Reflow Corresponding to Figure Above

Step	Setting	CONSTRAINTS		
		Temp (°C)	Time (sec)	Rate (°C/sec)
A	T_{room}	25		
B	T_{Smin}	150		
C	T_{Smax}	200	$60 < t_{BC} < 120$	
D	$T_{Liquidus}$	217		$r_{(TLiquidus-TPmax)} < 3$
E	T_{Pmin} [255°C, 260°C]	255		$r_{(TLiquidus-TPmax)} < 3$
F	T_{Pmax} [260°C, 265°C]	260	$t_{AF} < 480$	$r_{(TLiquidus-TPmax)} < 3$
G	T_{Pmin} [255°C, 260°C]	255	$10< t_{EG} < 30$	$r_{(TPmax-TLiquidus)} < 4$
H	$T_{Liquidus}$	217	$60 < t_{DH} < 120$	
I	T_{room}	25		

Note: For users T_{Pmax} must not exceed the classification temperature (260°C).
For suppliers T_{Pmax} must equal or exceed the classification temperature.

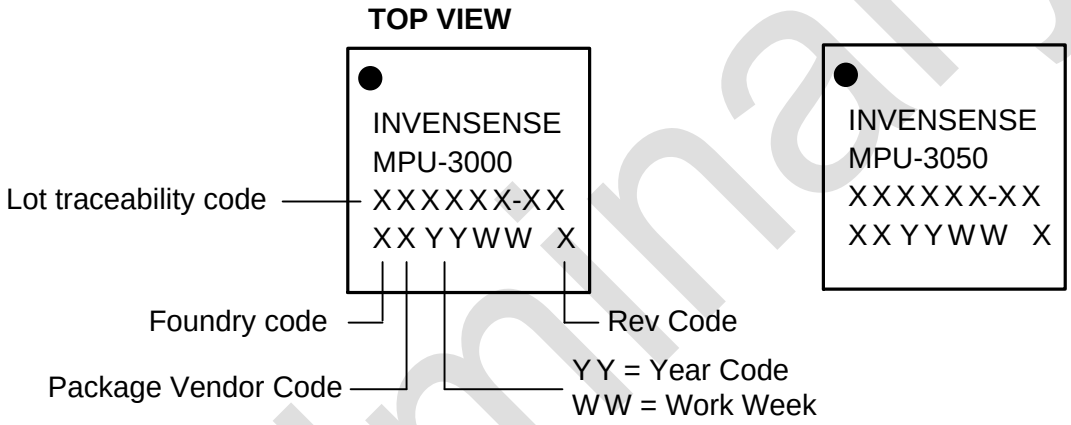
Preliminary

8.4.9 Storage Specifications

The storage specification of the MPU-30X0 gyroscope conforms to IPC/JEDEC J-STD-020D.01 Moisture Sensitivity Level (MSL) 3.

Calculated shelf-life in moisture-sealed bag	12 months -- Storage conditions: <40°C and <90% RH
After opening moisture-sealed bag	168 hours -- Storage conditions: ambient ≤30°C at 60%RH

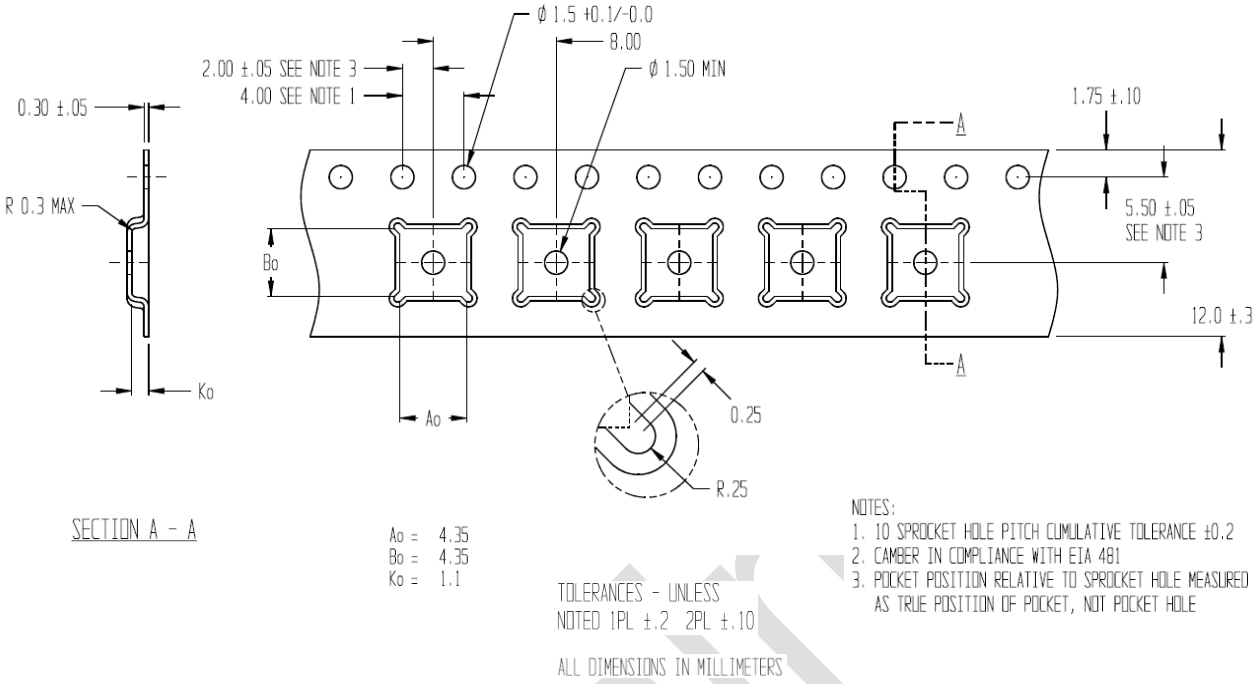
8.5 Package Marking Specification



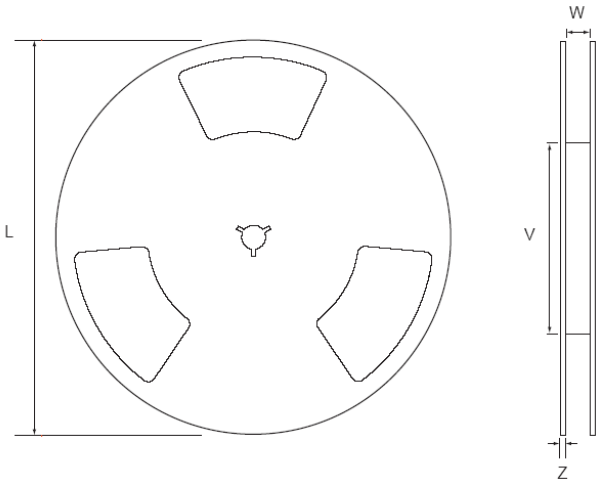
Package Marking Specification

Preliminary

8.6 Tape & Reel Specification



Tape Dimensions

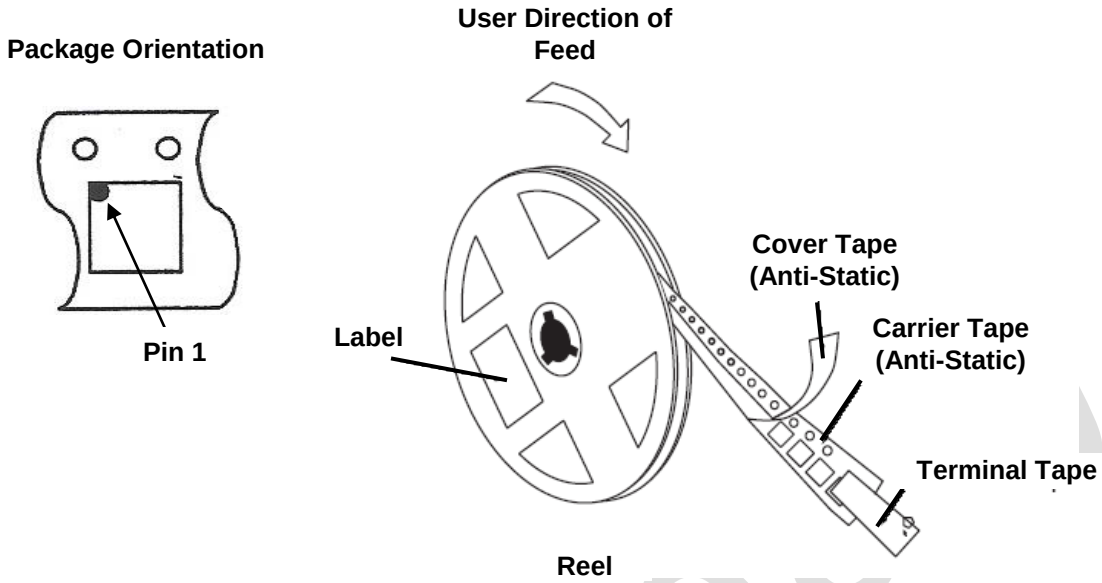


Reel Outline Drawing

Reel Dimensions and Package Size

PACKAGE SIZE	REEL (mm)			
	L	V	W	Z
4x4	330	100	13.2	2.2

Preliminary

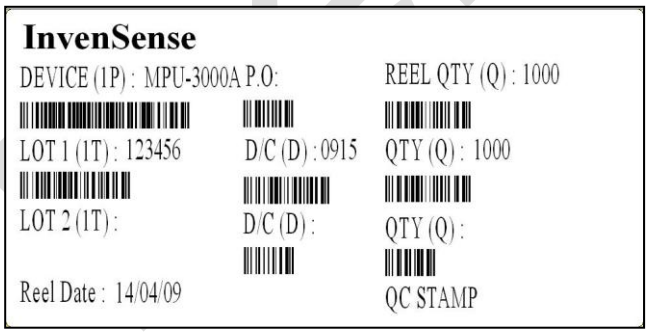


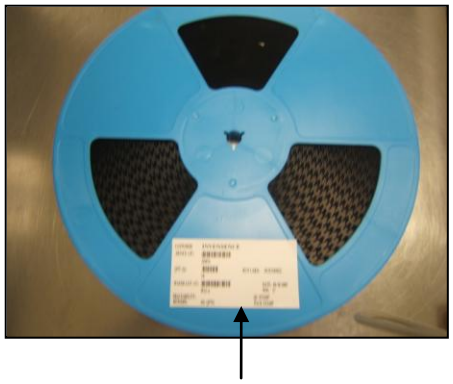
Tape and Reel Specification

Reel Specifications

Quantity Per Reel	5,000
Reels per Box	1
Boxes Per Carton (max)	3
Pieces per Carton (max)	15,000

8.7 Label

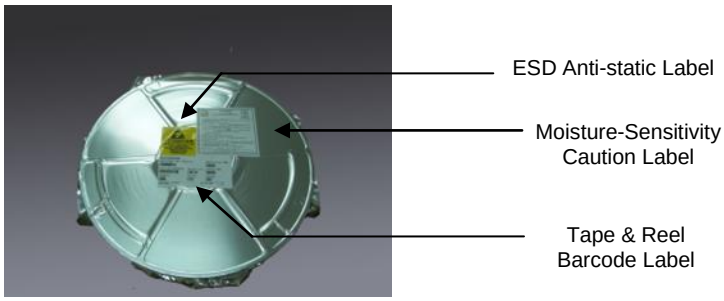




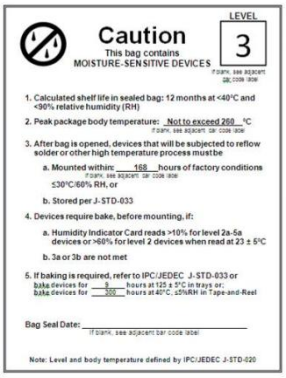
Location of Label

Preliminary

8.8 Packaging



Moisture Barrier Bag With Labels



Moisture-Sensitive Caution Label



Reel in Box



Box with Tape & Reel Label

Preliminary

9 Reliability

9.1 Qualification Test Policy

Before InvenSense products are released for production, they complete a series of qualification tests. The Qualification Test Plan for the MPU-30X0 followed the JEDEC JESD47G.01 Standard, "Stress-Test-Driven Qualification of Integrated Circuits." The individual tests are described below.

9.2 Qualification Test Plan

Accelerated Life Tests

TEST	Method/Condition	Lot Quantity	Sample / Lot	Acc / Reject Criteria
High Temperature Operating Life (HTOL/LFR)	JEDEC JESD22-A108C, Dynamic, 3.63V biased, Tj>125°C [read-points 168, 500, 1000 hours]	3	77	(0/1)
Highly Accelerated Stress Test (1) (HAST)	JEDEC JESD22-A118 Condition A, 130°C, 85%RH, 33.3 psia., unbiased, [read-point 96 hours]	3	77	(0/1)
High Temperature Storage Life (HTS)	JEDEC JESD22-A103C, Cond. A, 125°C, Non-Biased Bake [read-points 168, 500, 1000 hours]	3	77	(0/1)

Device Component Level Tests

TEST	Method/Condition	Lot Quantity	Sample / Lot	Acc / Reject Criteria
ESD-HBM	JEDEC JESD22-A114F, (1.5KV)	1	3	(0/1)
ESD-MM	JEDEC JESD22-A115-A, (200V)	1	3	(0/1)
Latch Up	JEDEC JESD78B Class II (2), 125°C; Level B ±60mA	1	6	(0/1)
Mechanical Shock	JEDEC JESD22-B104C, Mil-Std-883H, method 2002.5, Cond. E, 10,000*g's*, 0.2ms, ±X, Y, Z – 6 directions, 5 times/direction	3	30	(0/1)
Vibration	JEDEC JESD22-B103B, Variable Frequency (random), Cond. B, 5-500Hz, X, Y, Z – 4 times/direction	3	5	(0/1)
Temperature Cycling (TC) (1)	JEDEC JESD22-A104D Condition N, [-40°C to +85°C], Soak Mode 2 [5'], 100 cycles	3	77	(0/1)

Board Level Tests

TEST	Method/Condition	Lot Quantity	Sample / Lot	Acc / Reject Criteria
Board Mechanical Shock	JEDEC JESD22-B104C, Mil-Std-883H, method 2002.5, Cond. E, 10000*g's*, 0.2ms, +-X, Y, Z – 6 directions, 5 times/direction	1	5	(0/1)
Board Temperature Cycling (TC) (1)	JEDEC JESD22-A104D Condition N, [-40°C to +85°C], Soak Mode 2 [5'], 100 cycles	1	40	(0/1)

(1) Tests are preceded by MSL3 Preconditioning in accordance with JEDEC JESD22-A113F

Preliminary

10 Environmental Compliance

The MPU-30X0 is RoHS and Green compliant.

The MPU-30X0 is in full environmental compliance as evidenced in report HS-MPU-30X0A, Materials Declaration Data Sheet.

Environmental Declaration Disclaimer:
InvenSense believes this environmental information to be correct but cannot guarantee accuracy or completeness. Conformity documents for the above component constitutes are on file. InvenSense subcontracts manufacturing and the information contained herein is based on data received from vendors and suppliers, which has not been validated by InvenSense.

Preliminary

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